



Interessenverband
Netzimpedanz



HOCHSCHULE RUHR WEST
UNIVERSITY OF APPLIED SCIENCES

Measurement of Harmonic Power Flows

March 25th, 2021

Jan-Philipp Kitzig and
Gerd Bumiller

Hochschule Ruhr West, University of Applied Sciences

Outline

- Harmonics in Voltage and Current
- Harmonic Power Flows in Theory
- Metrological Challenges
- New Approaches
- Measurements

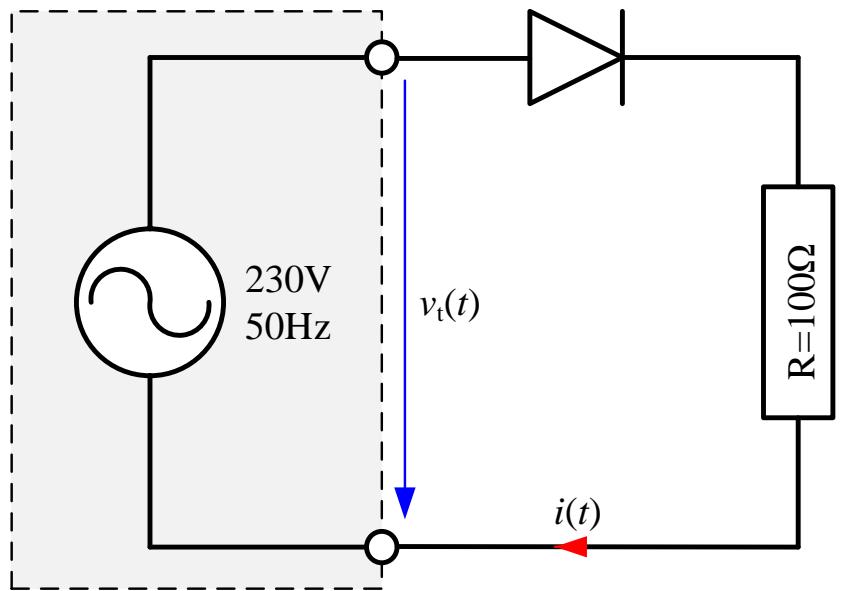
Harmonics in current

- Caused by non-linear current draw

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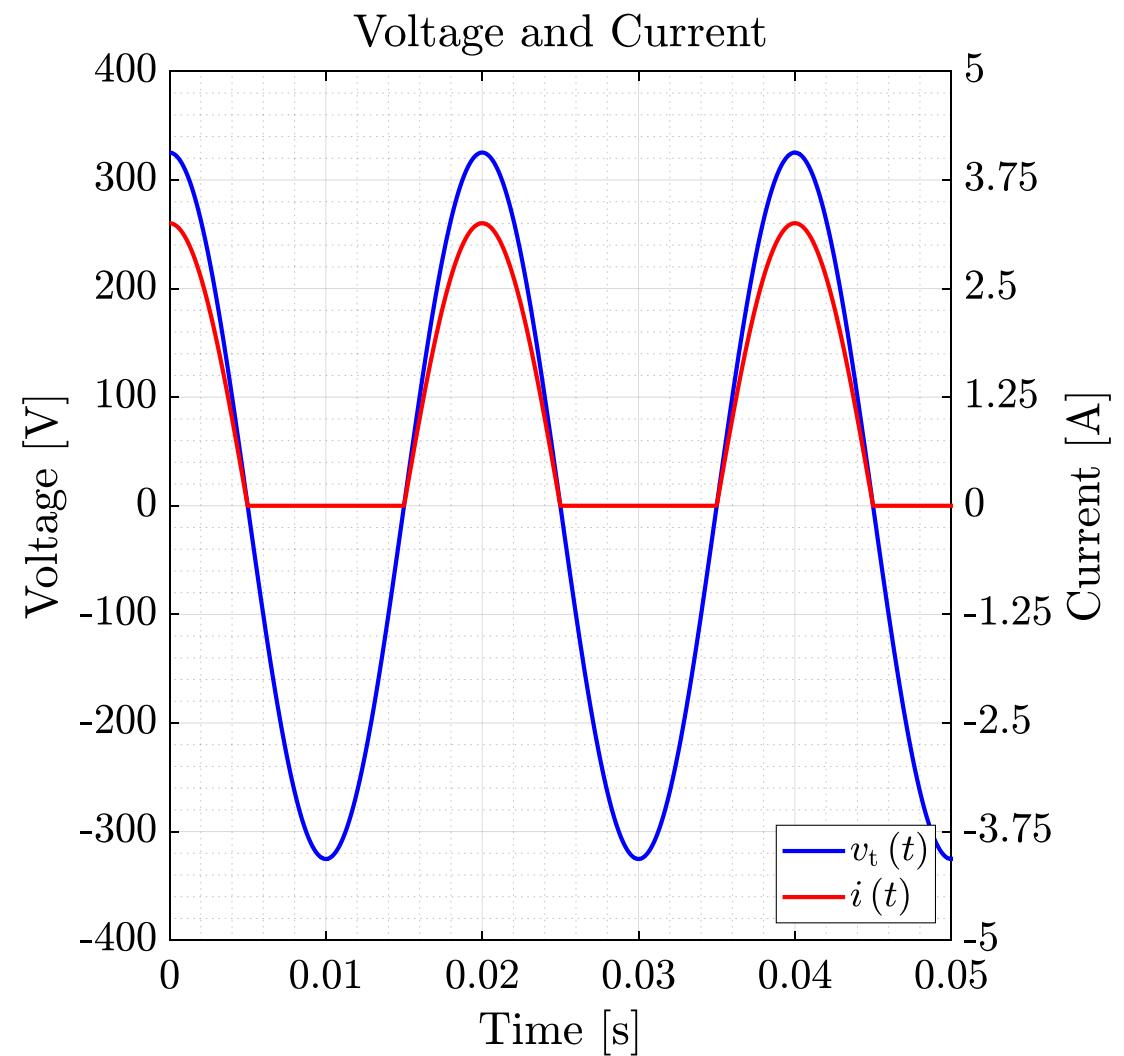
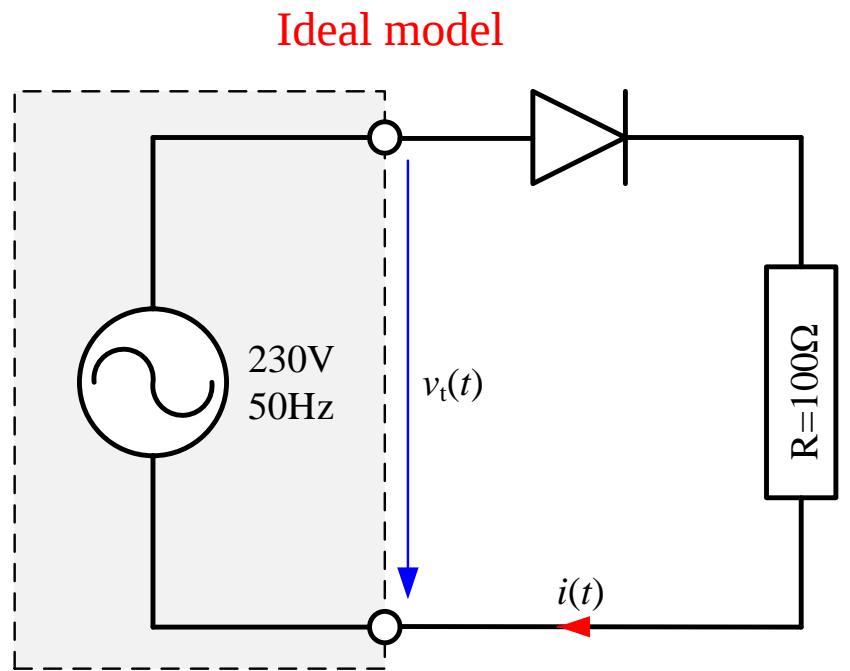
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Ideal model



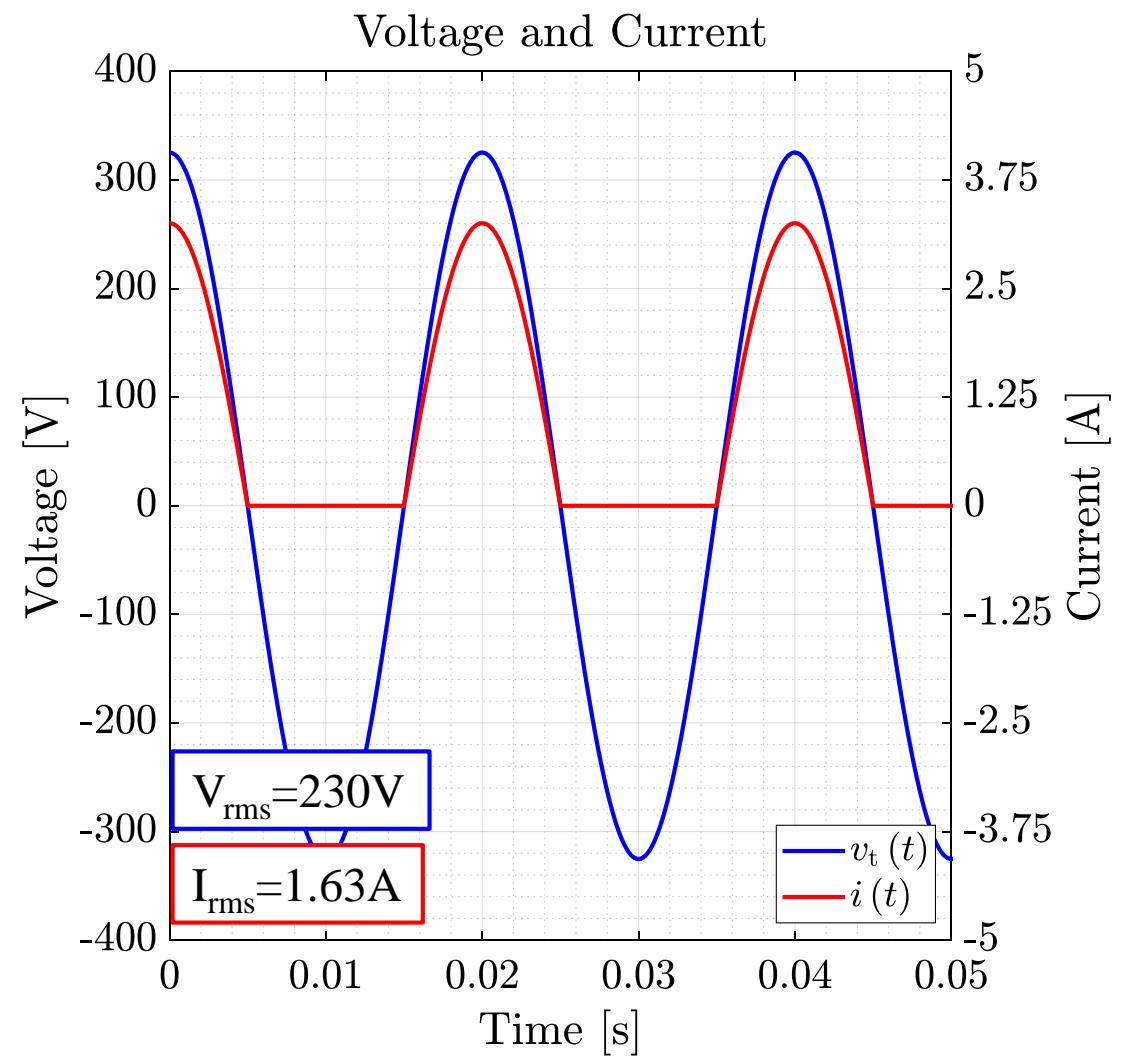
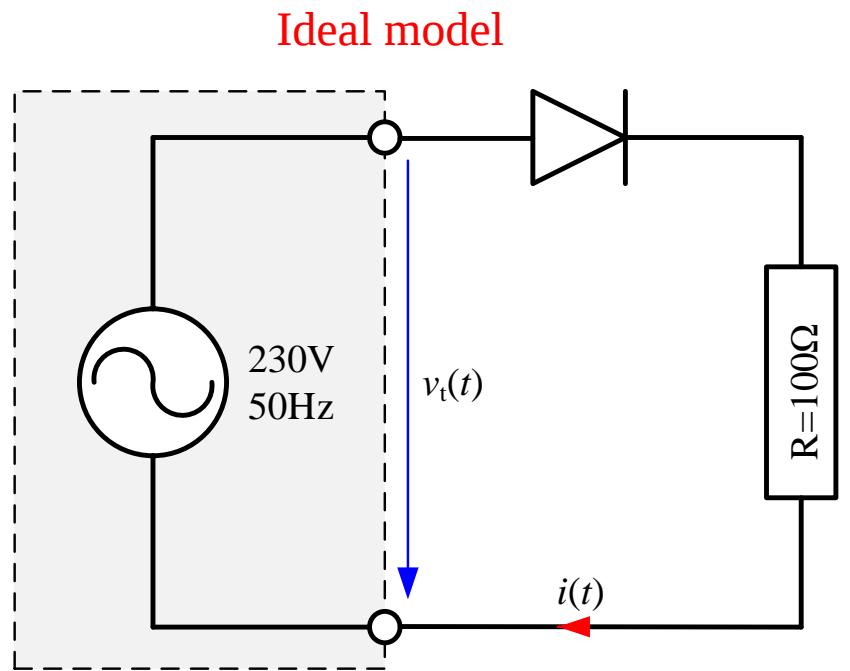
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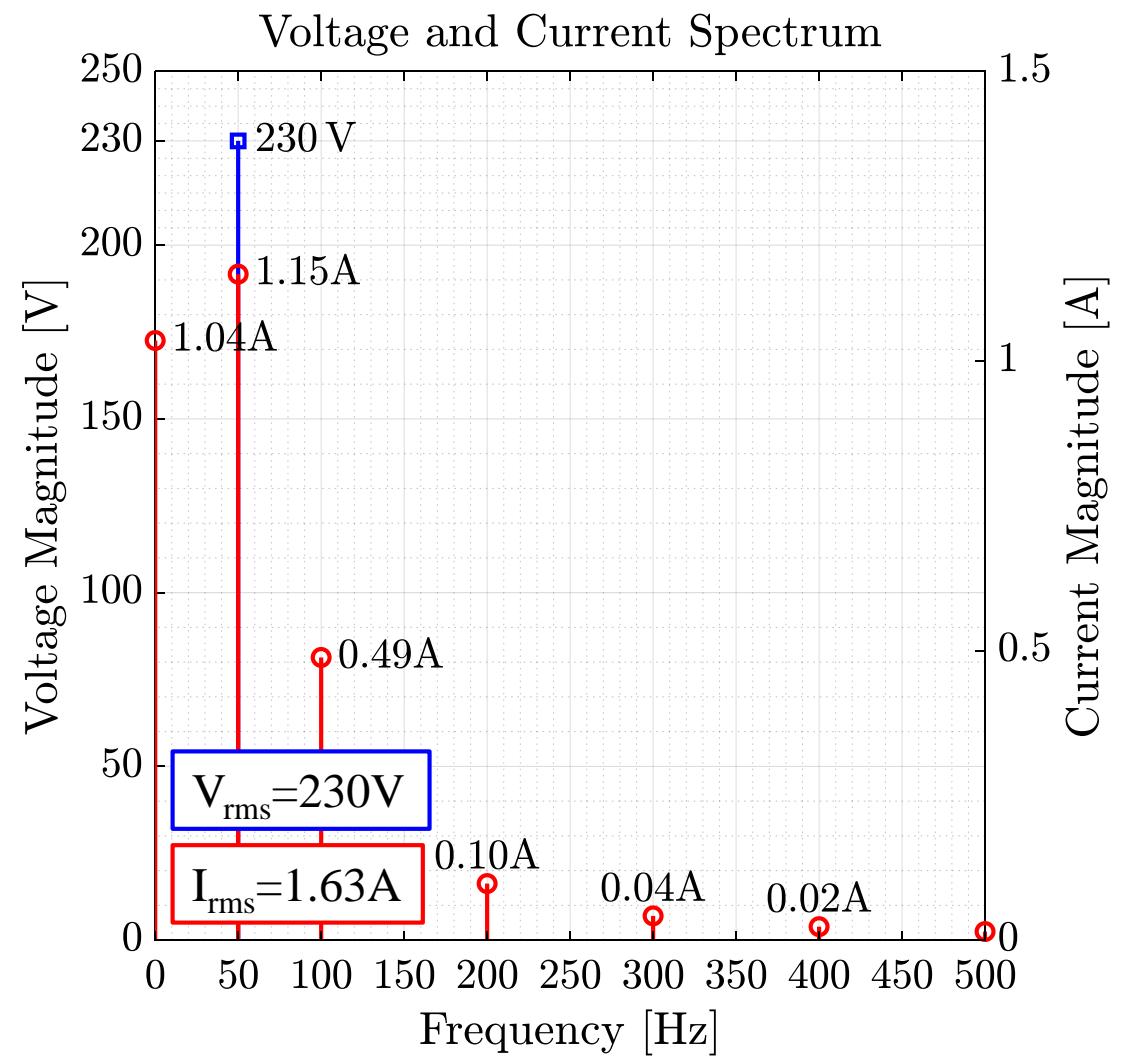
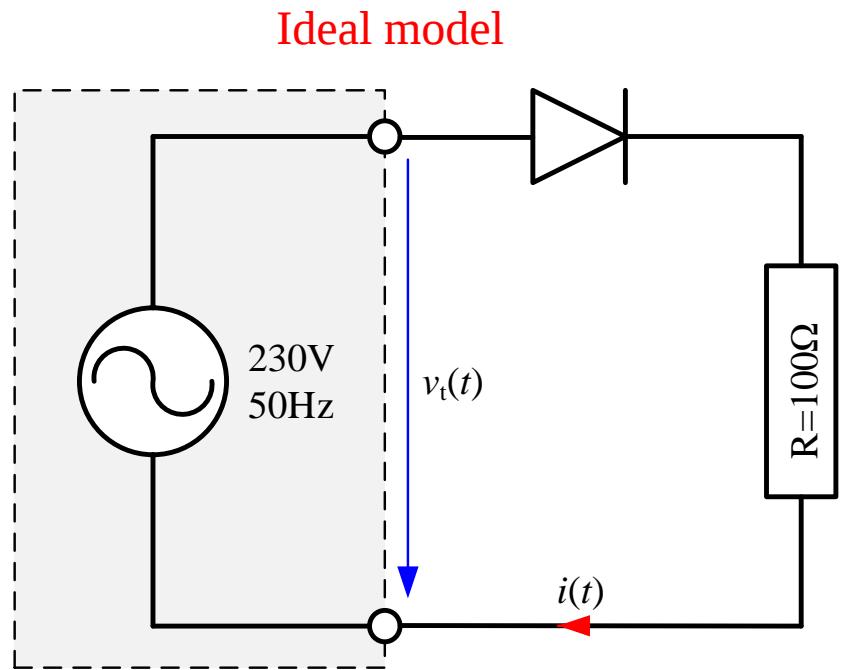
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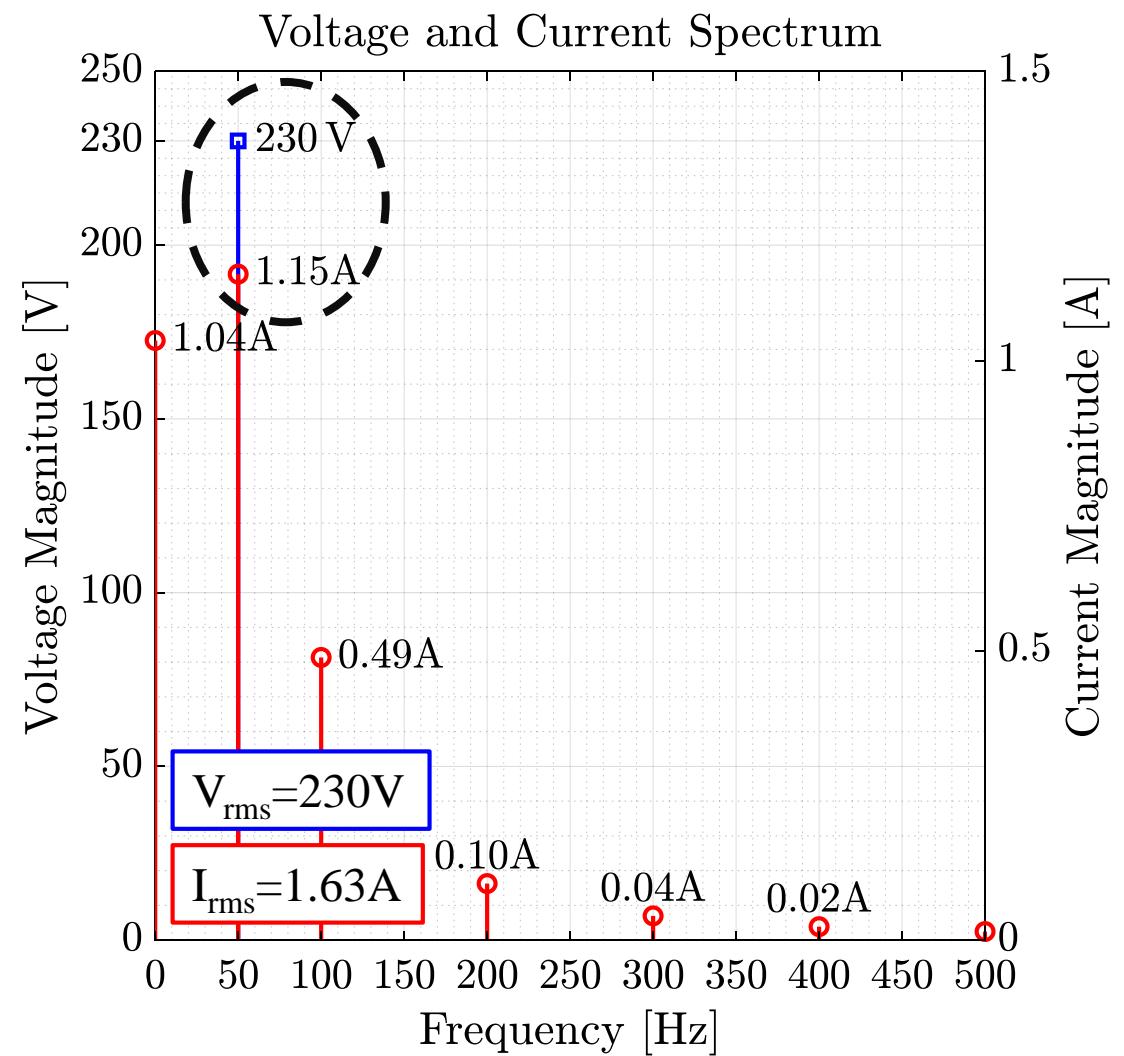
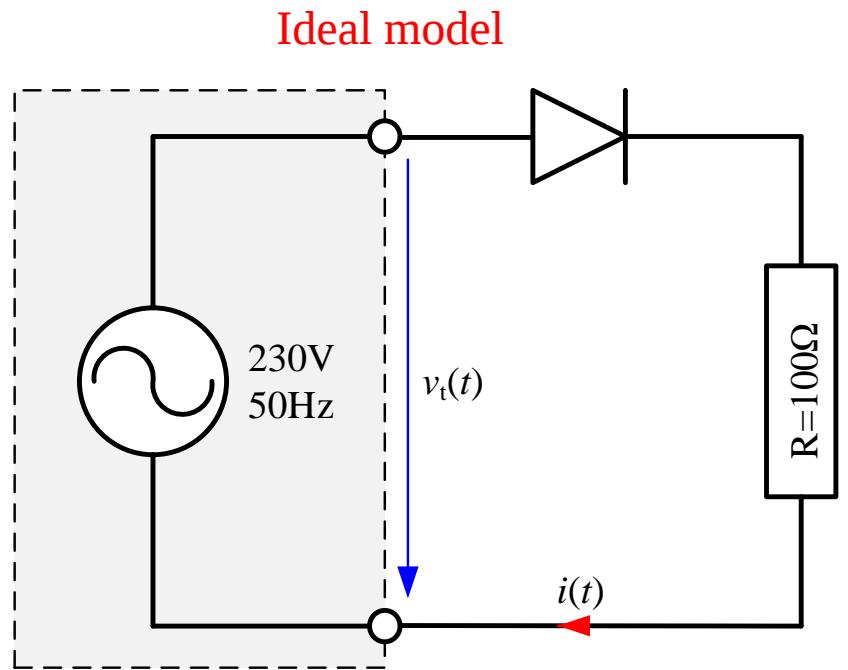
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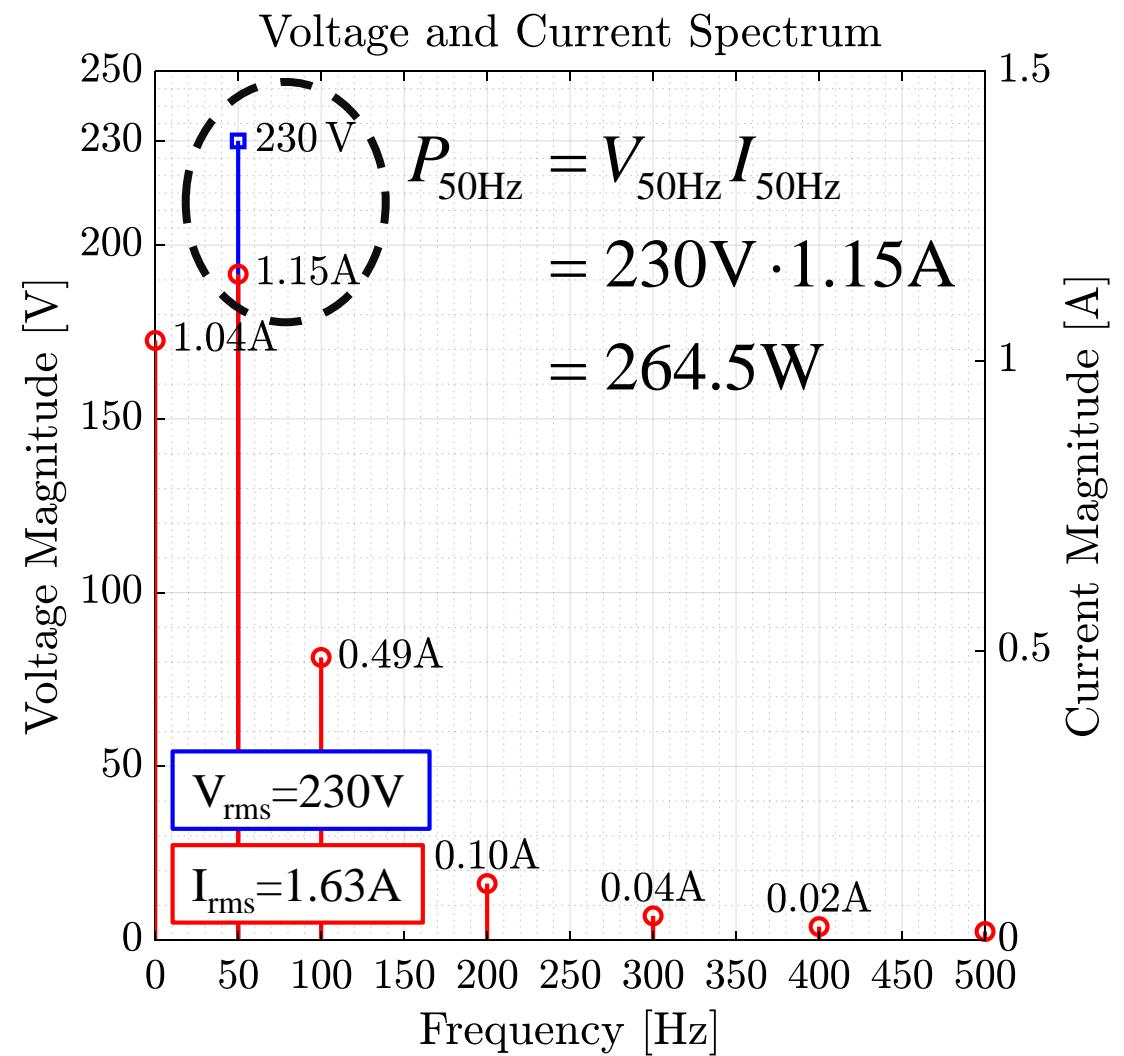
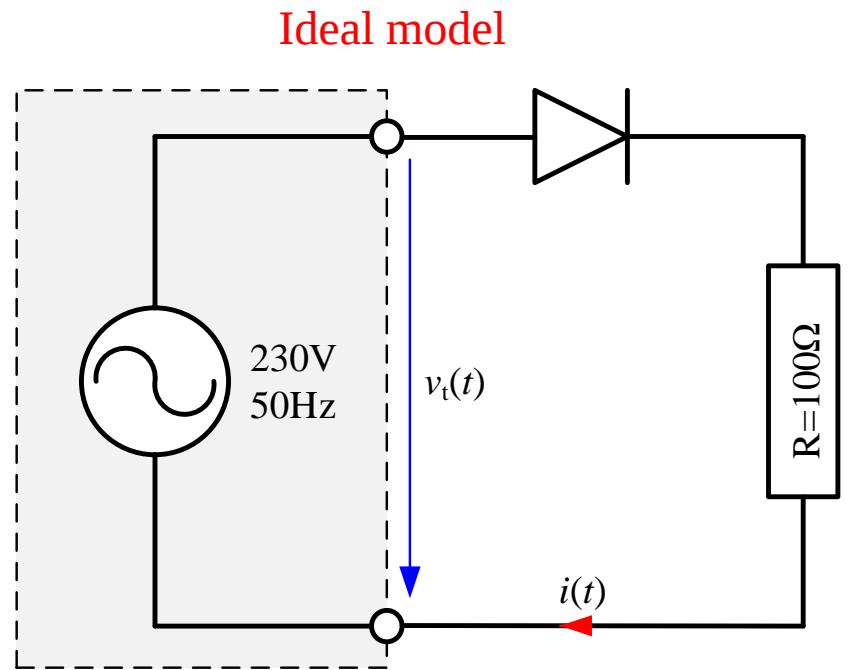
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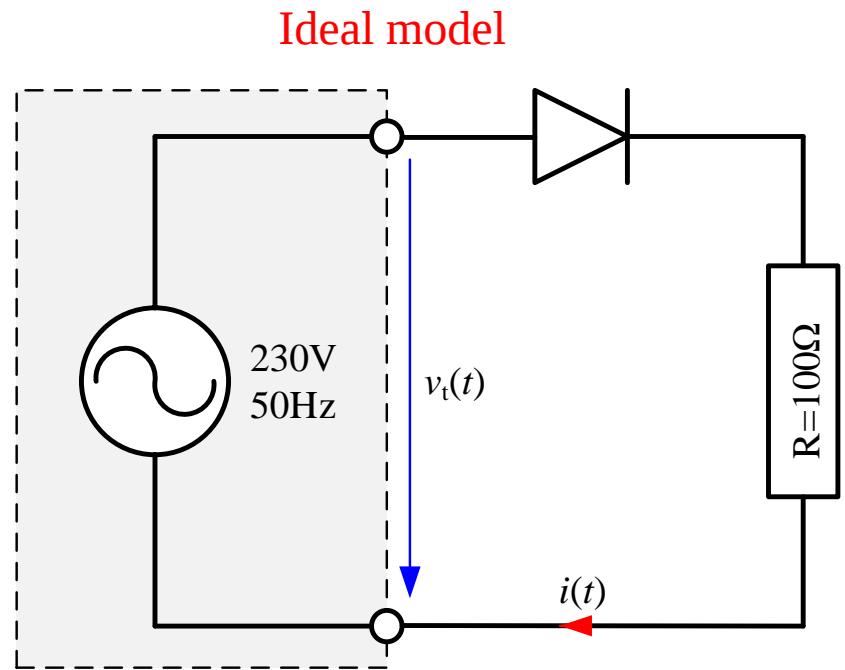
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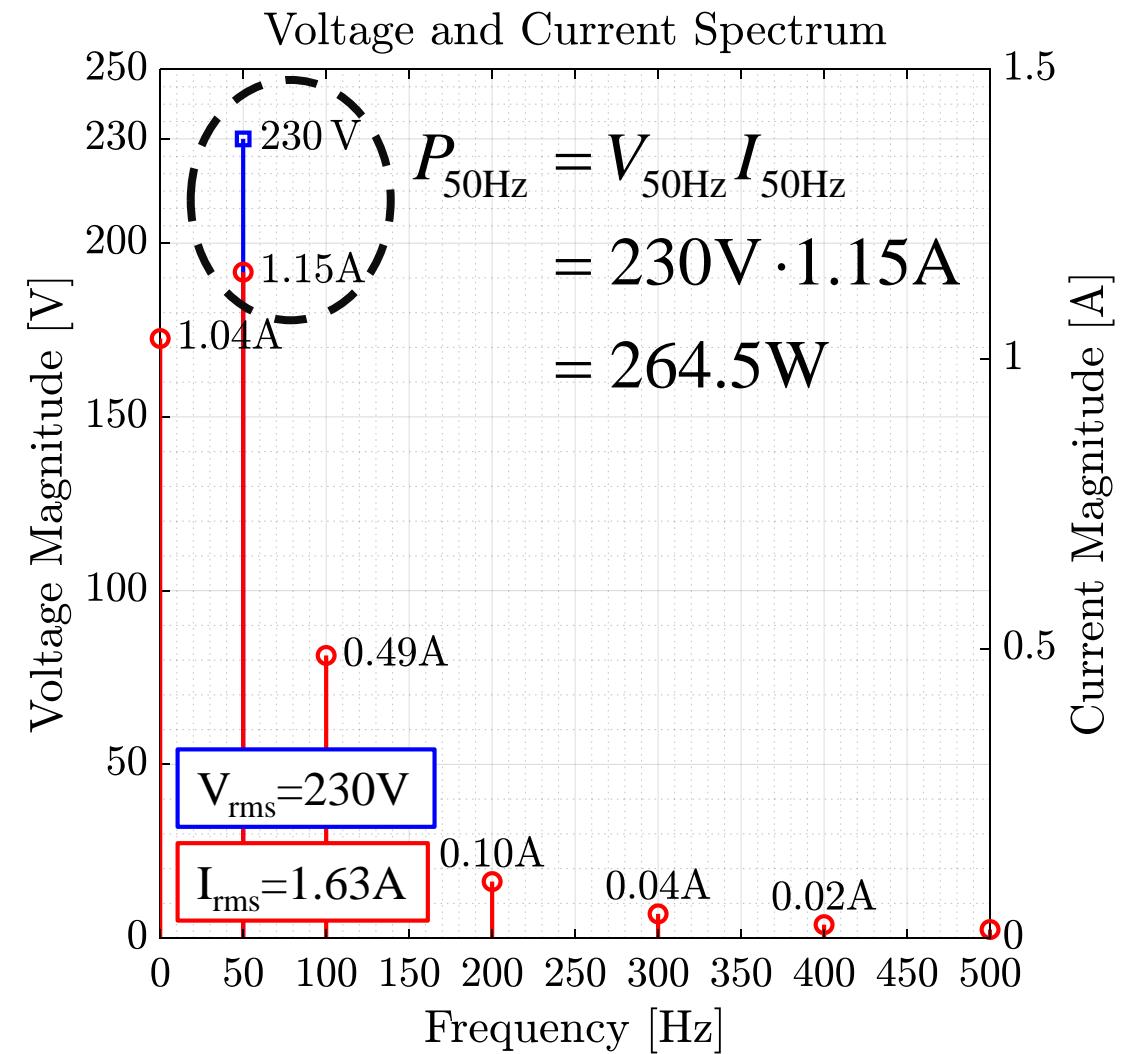


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$$P_{\text{tot}} = \frac{1}{T} \int_t^{t+T} [v_t(\tau)i(\tau)] d\tau = 264.5 \text{W}$$



Harmonics in voltage

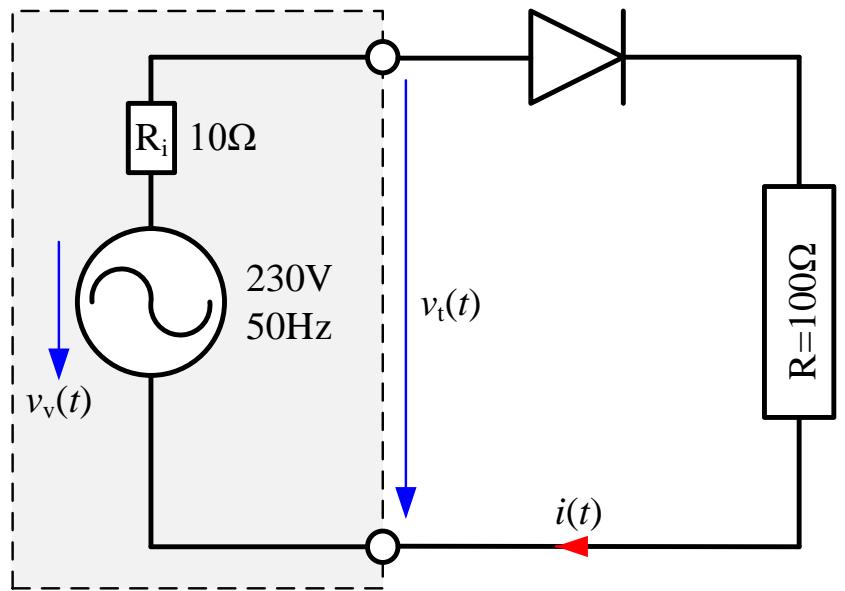
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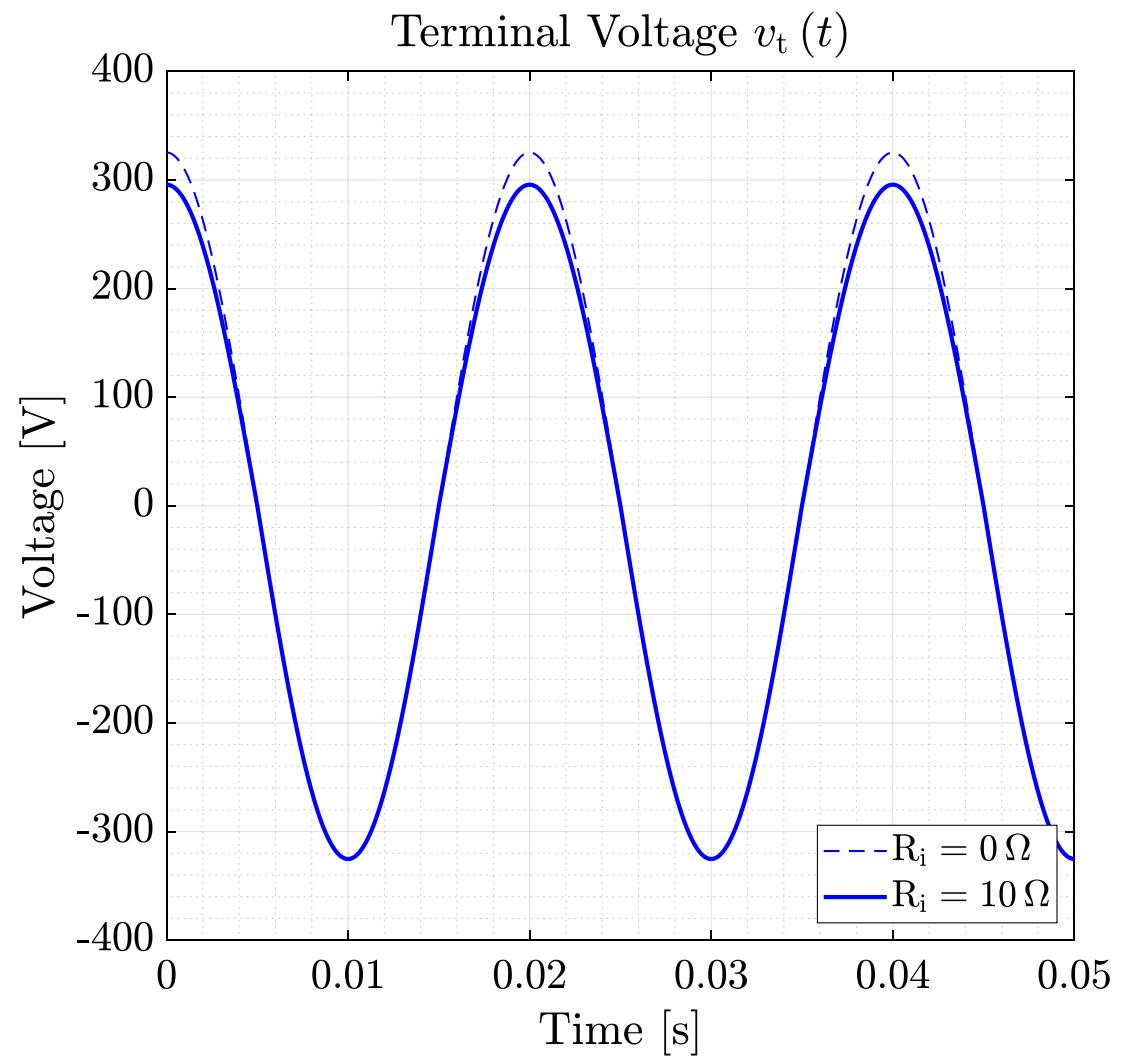
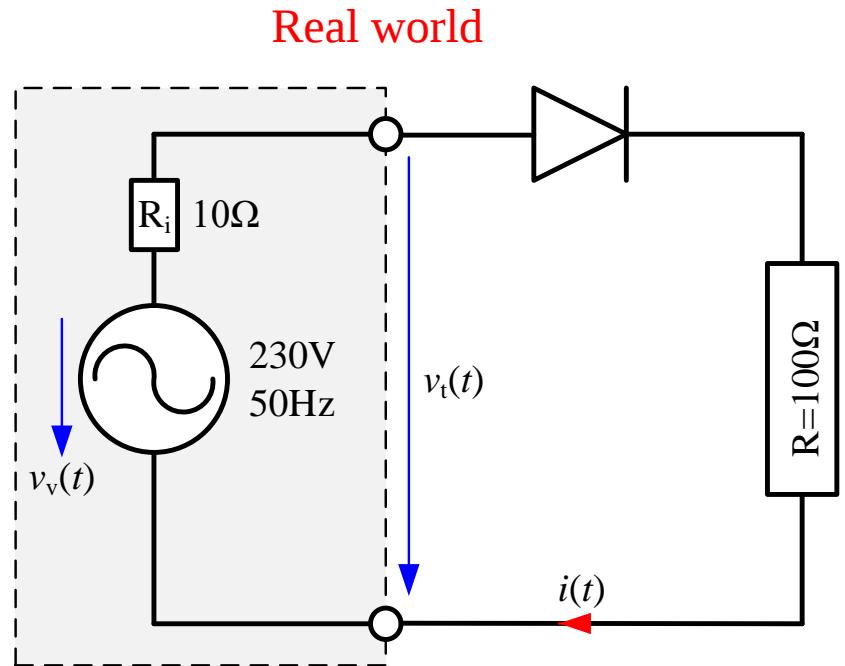
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Real world



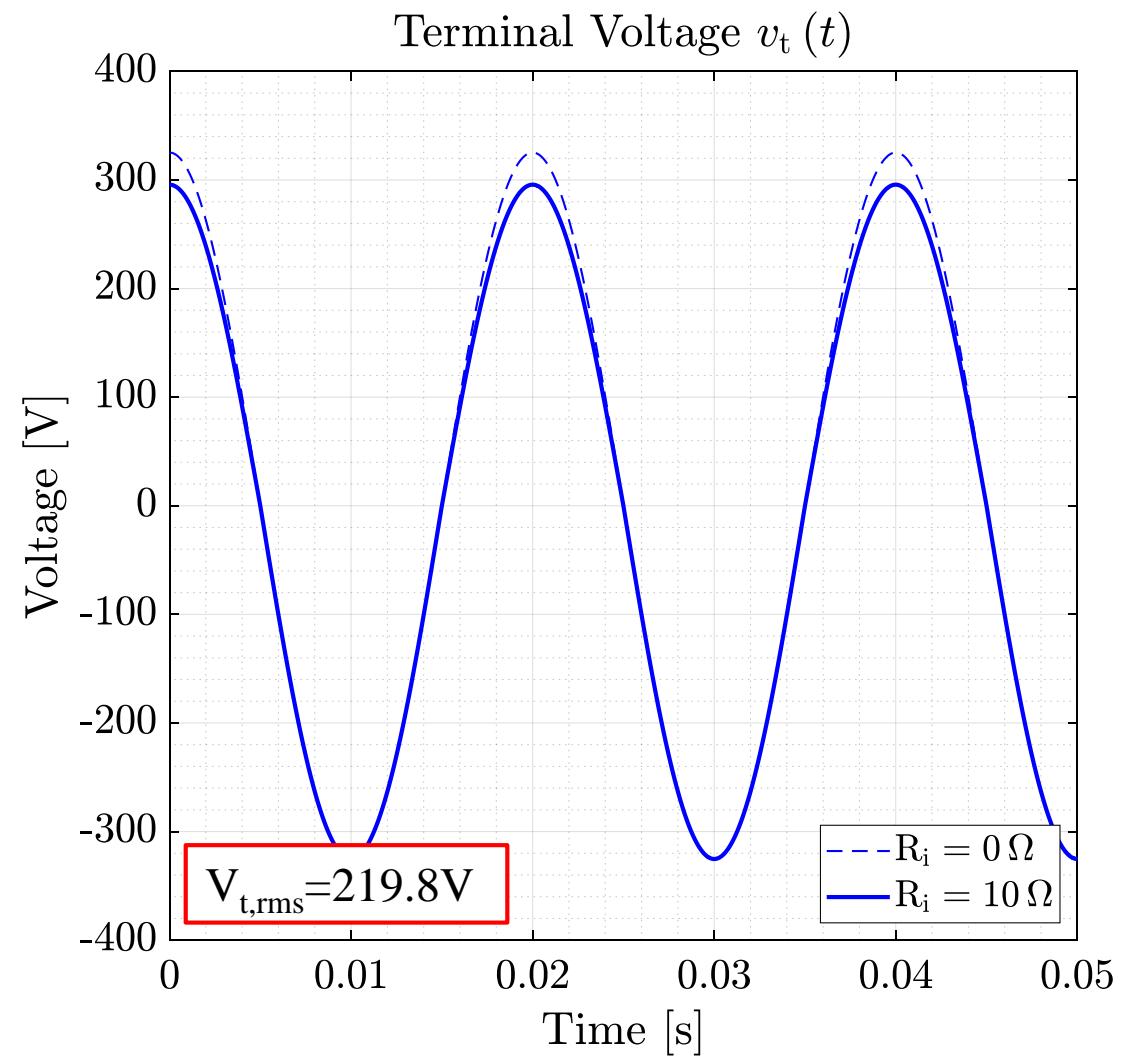
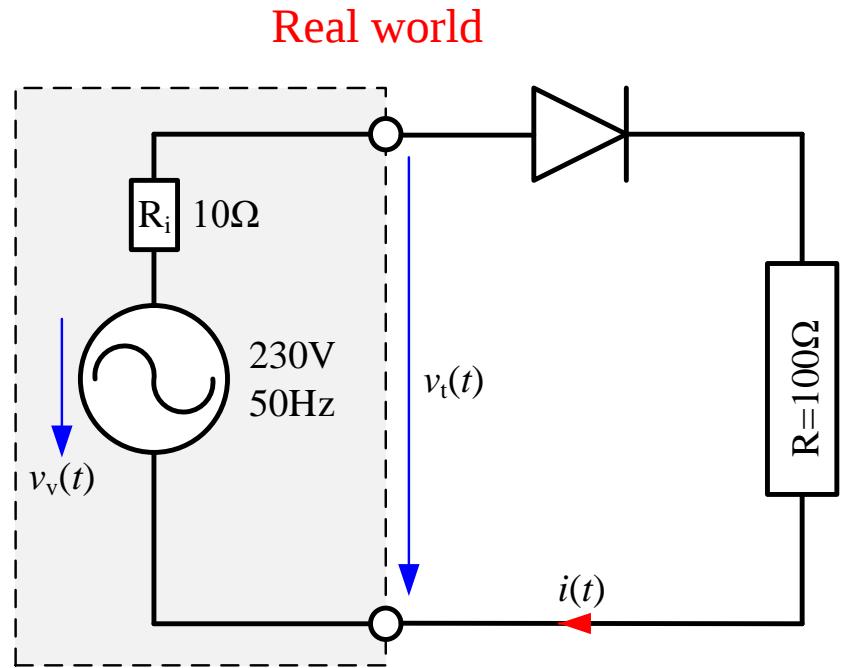
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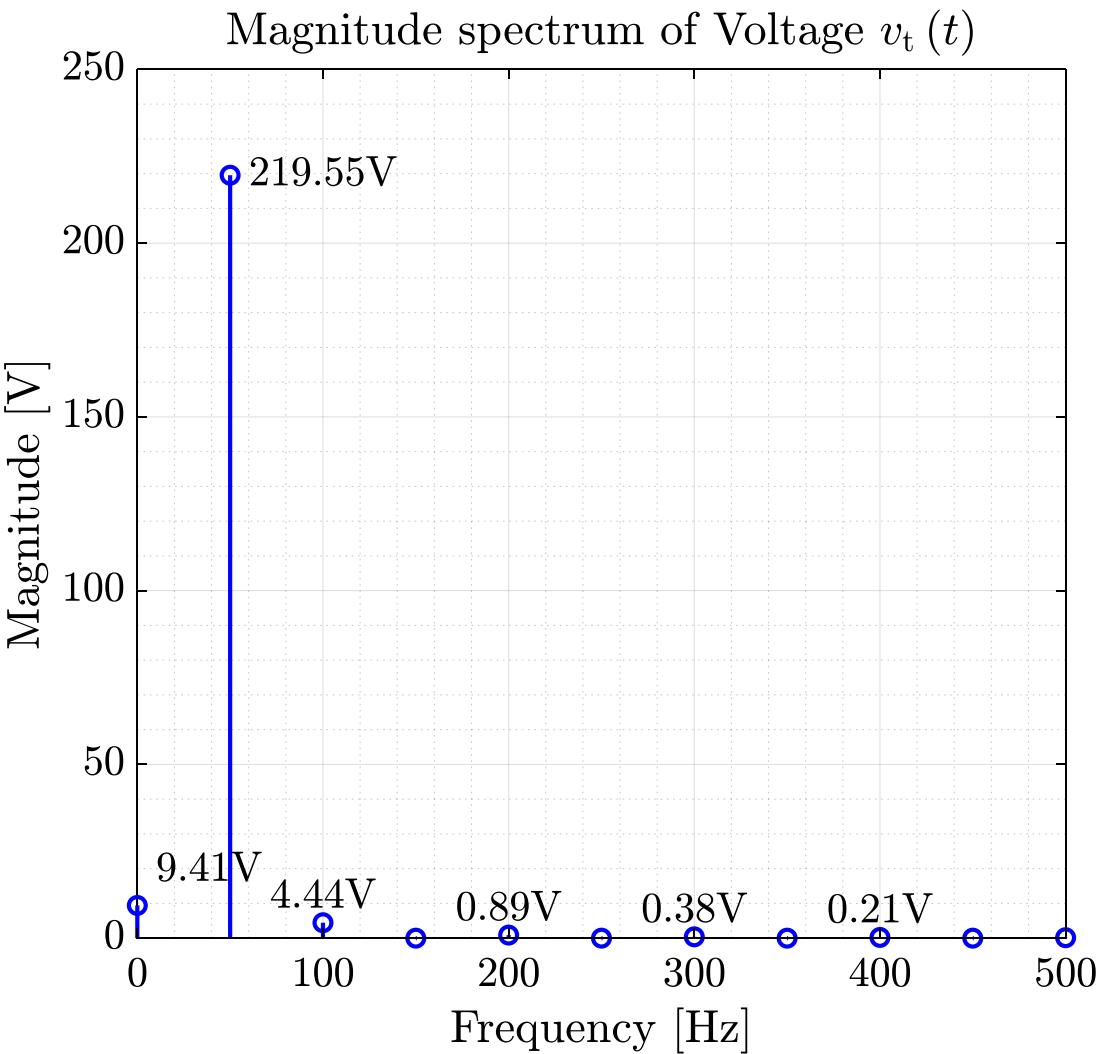
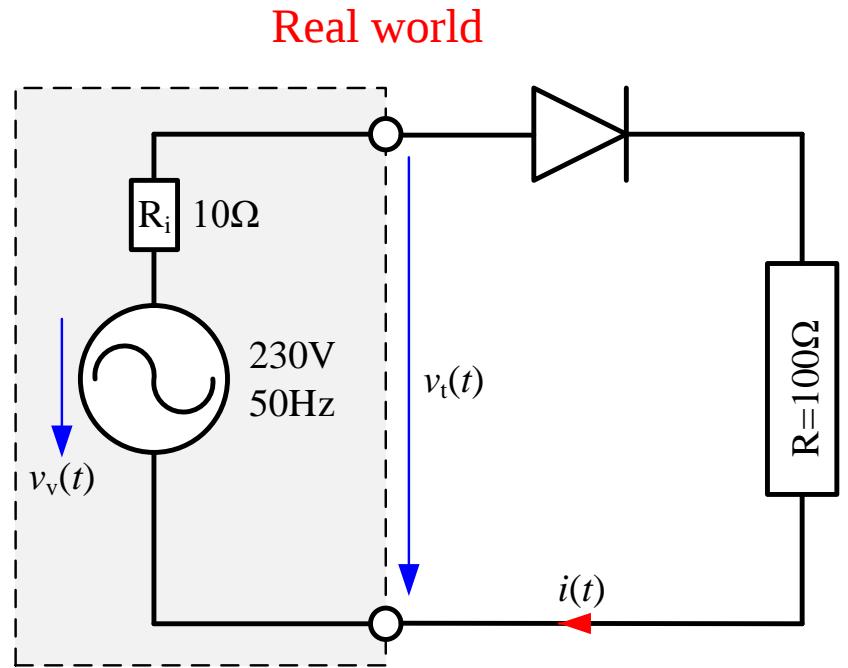
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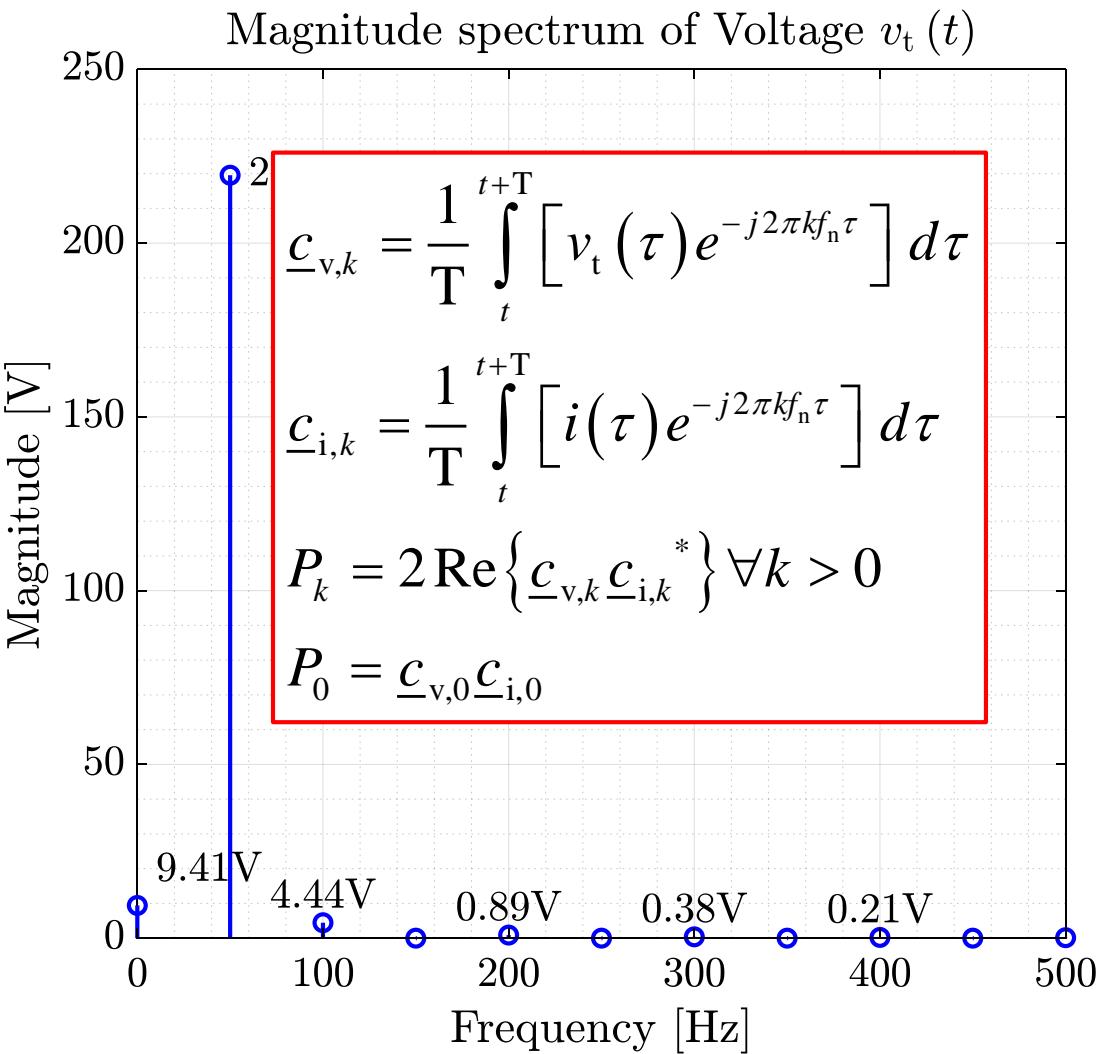
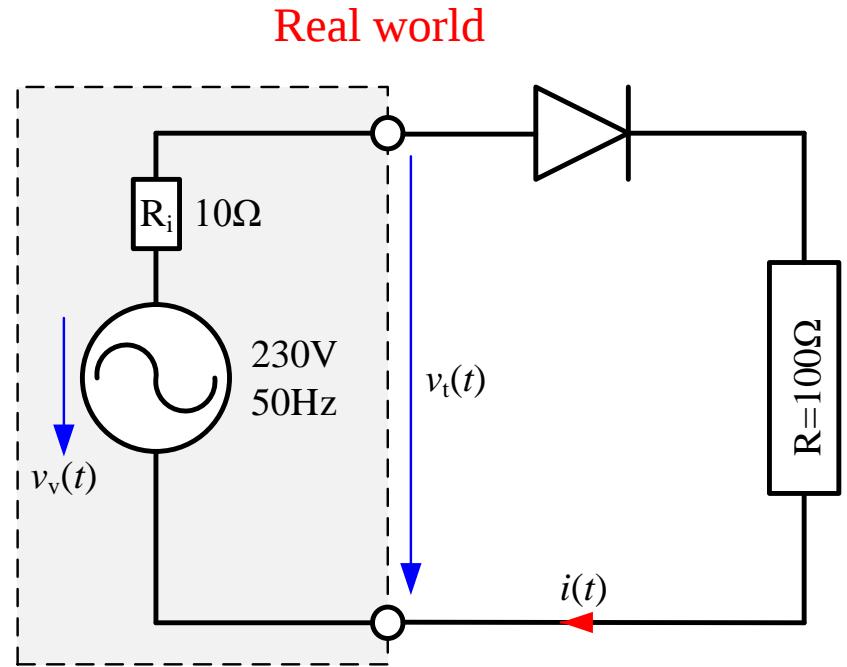
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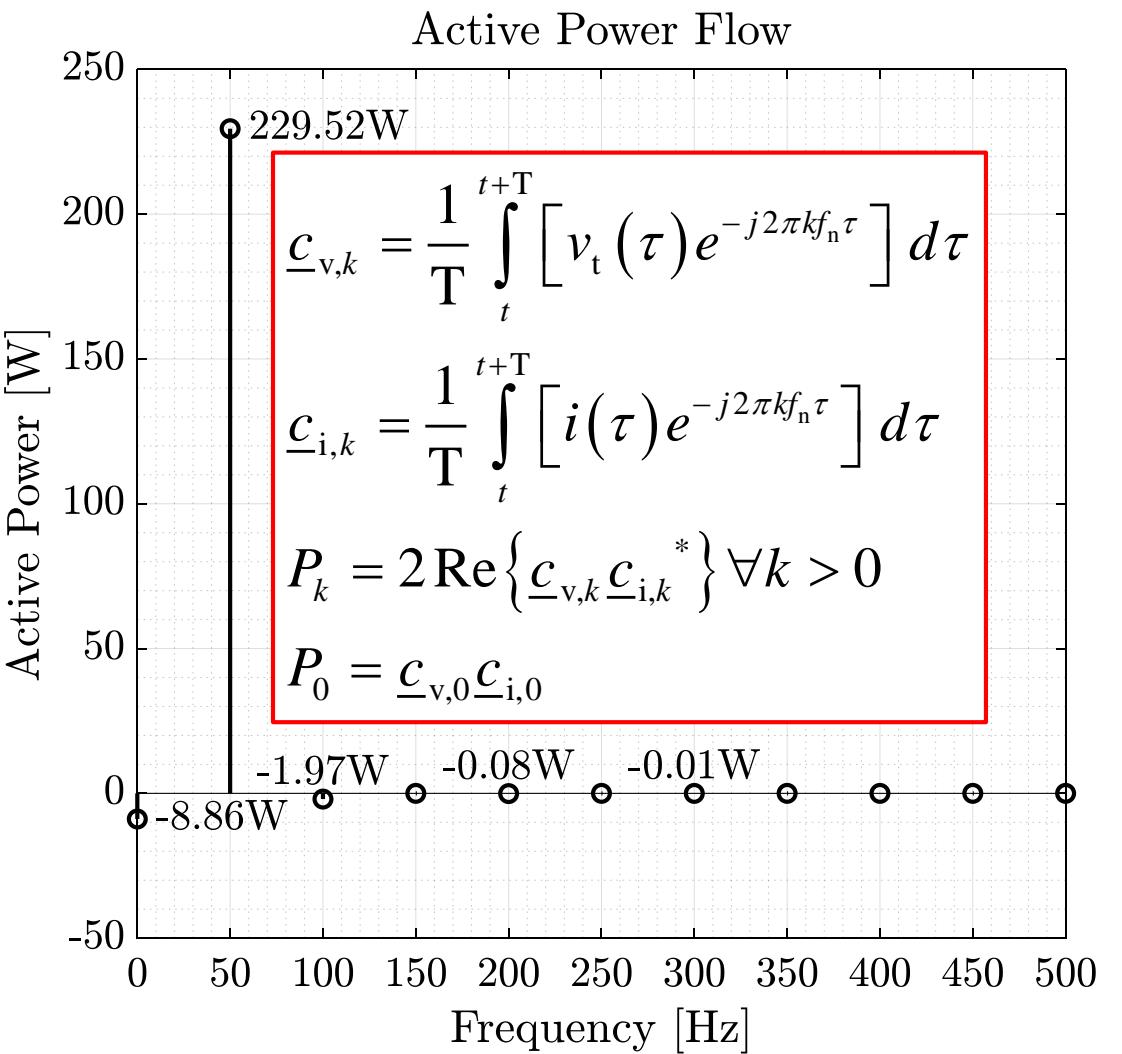
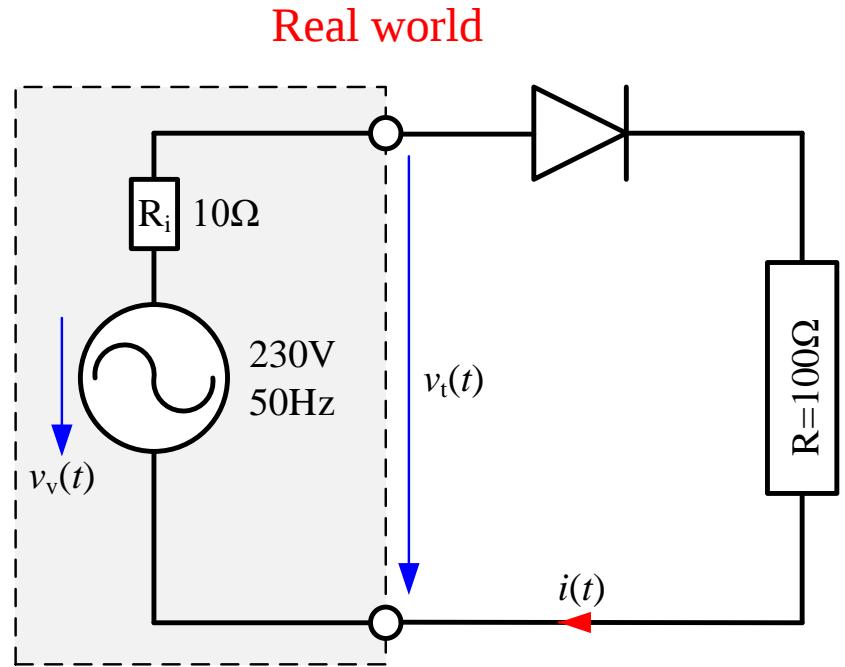
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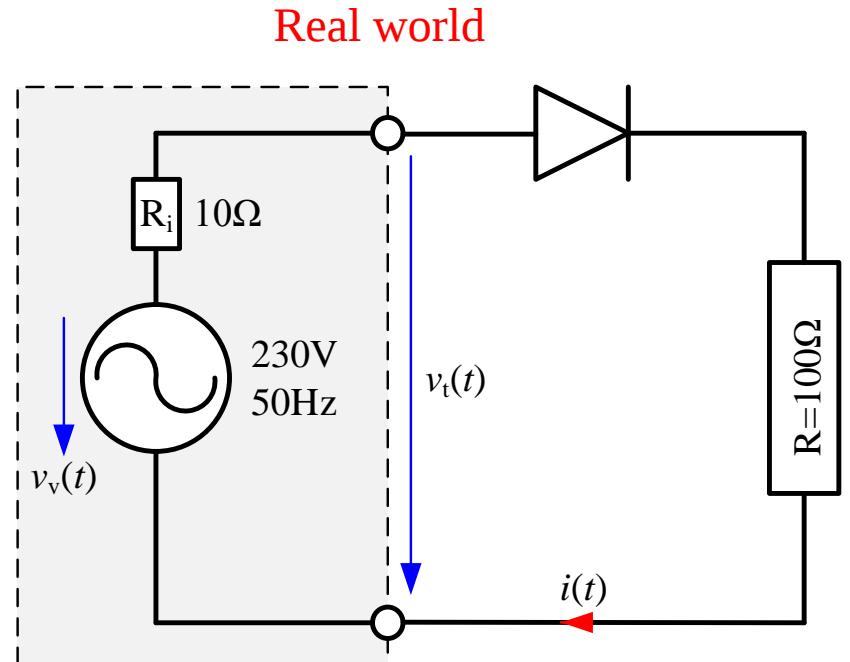
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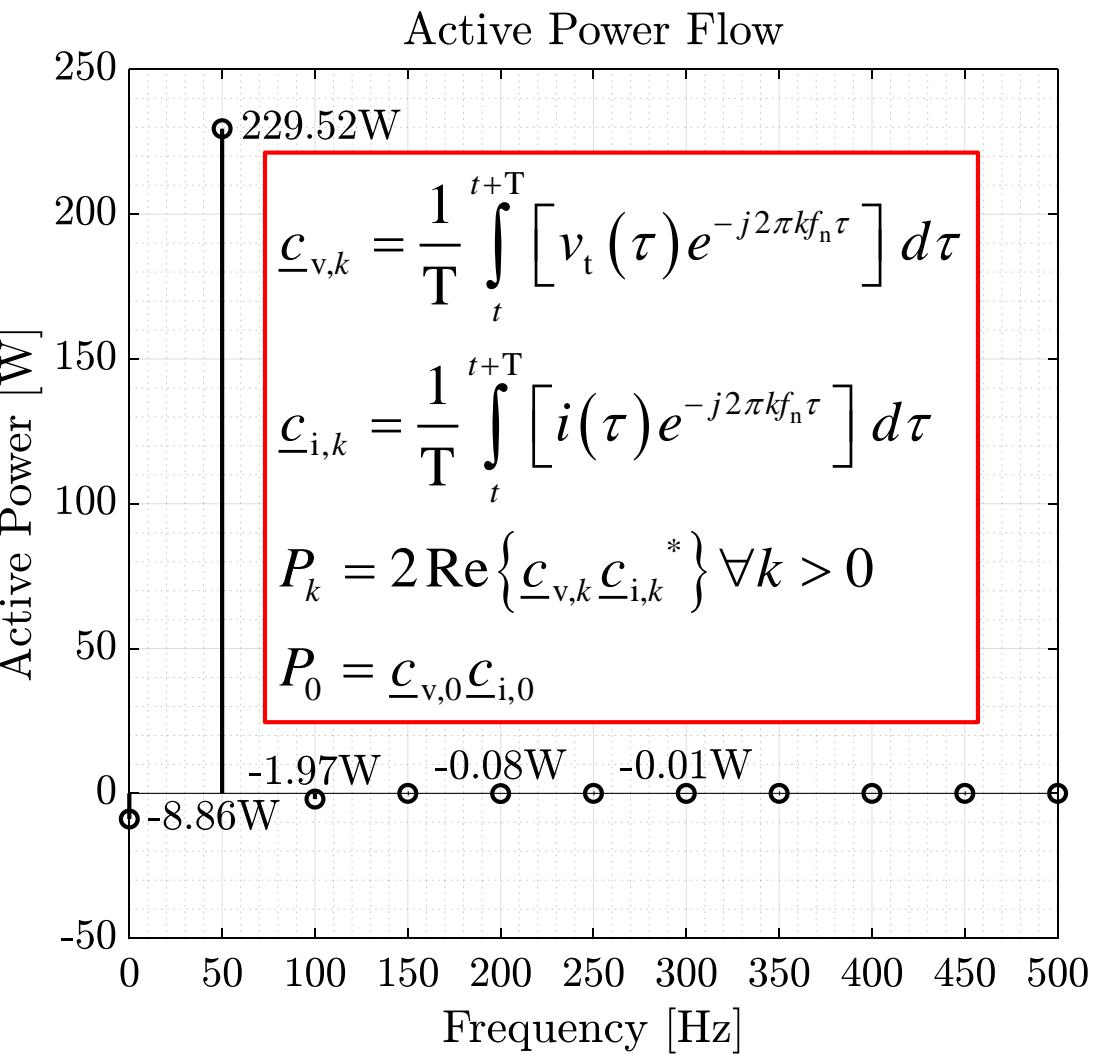
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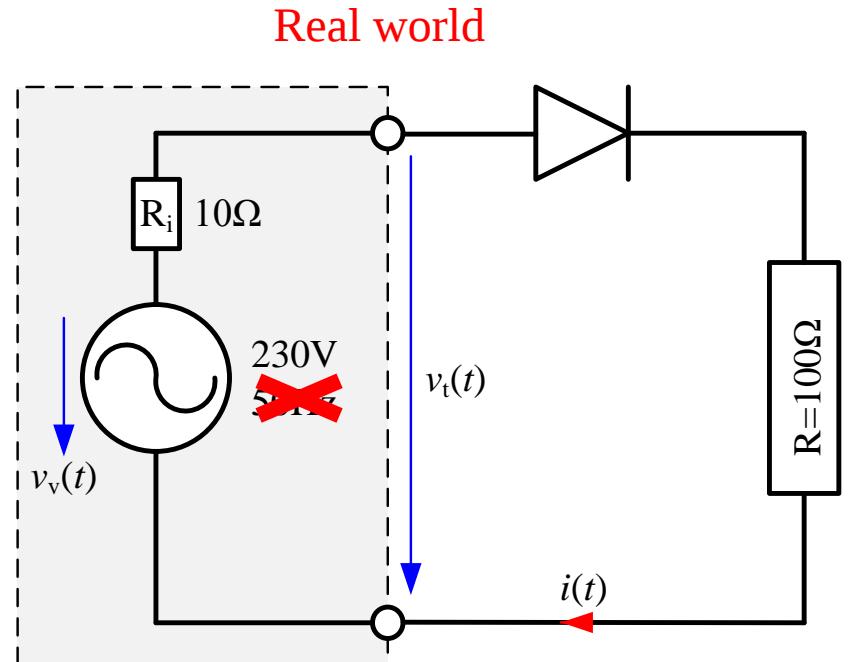
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$$= 218.59 \text{W}$$



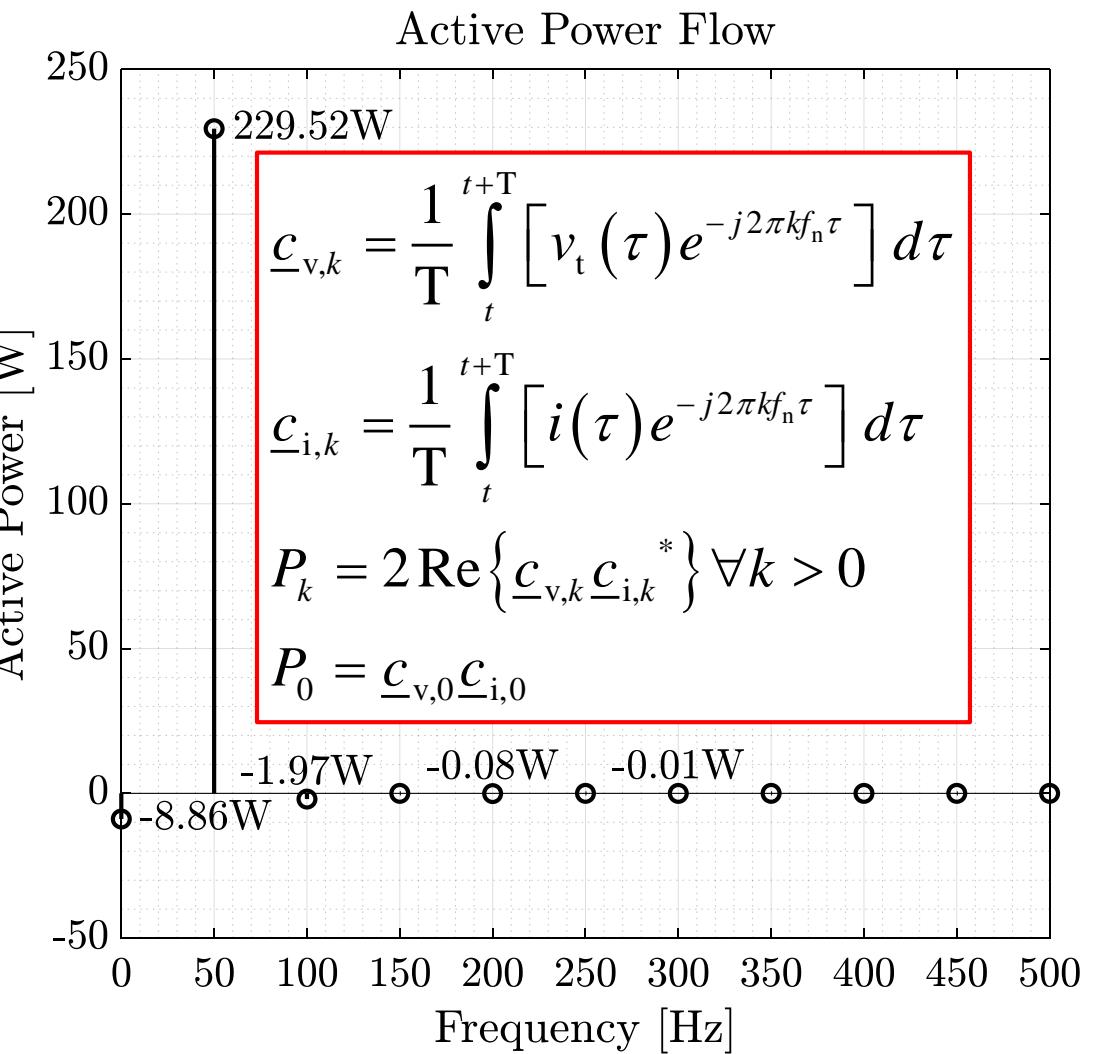
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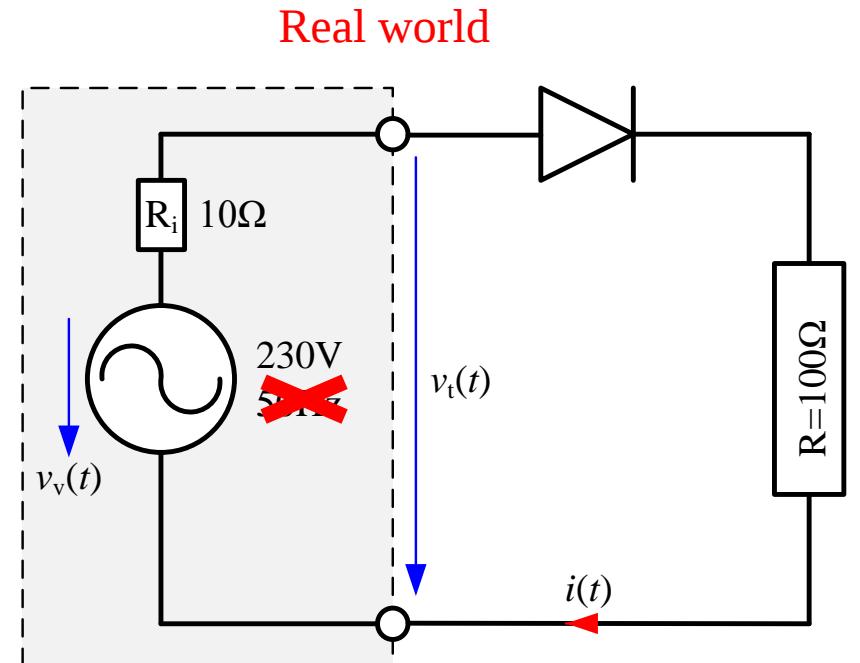
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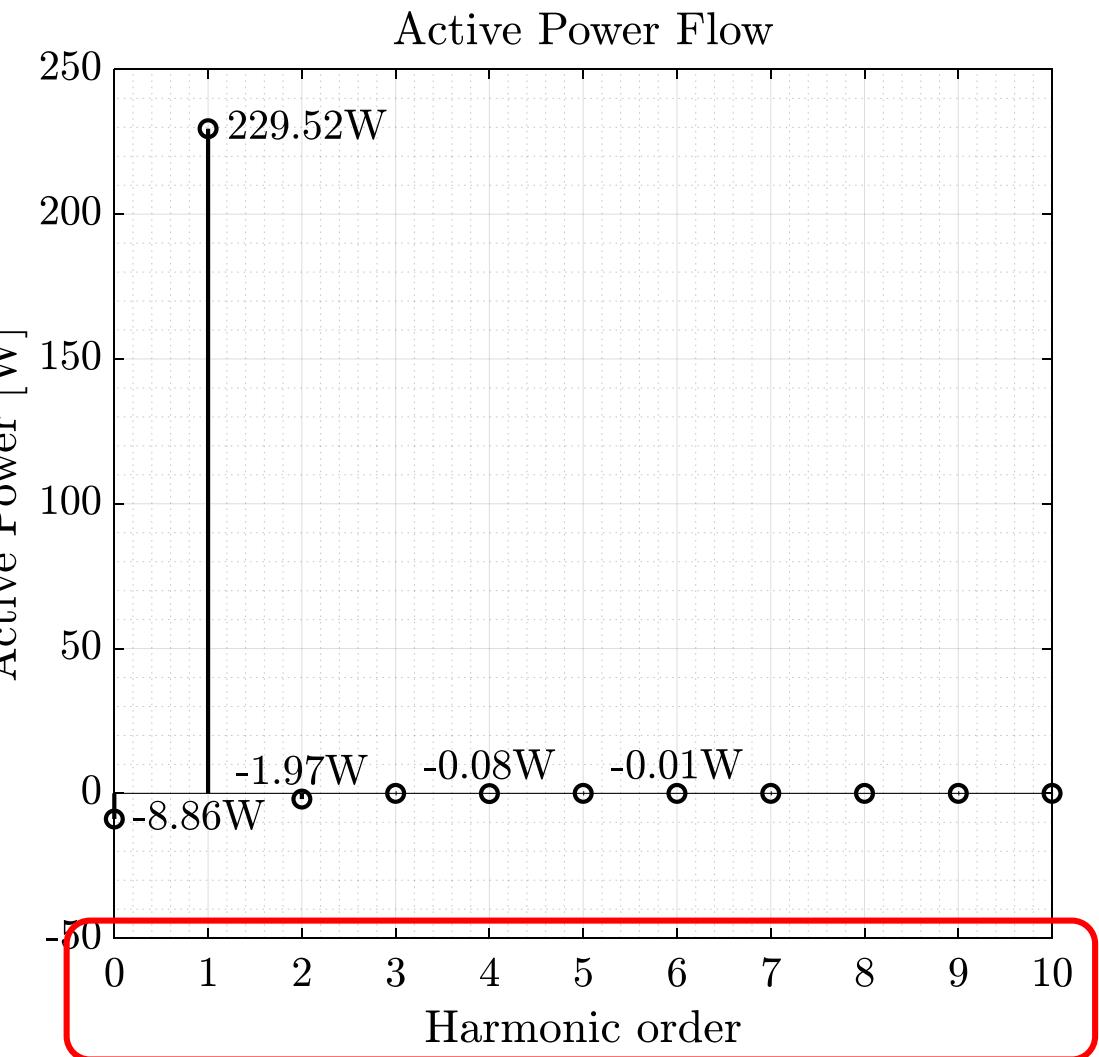
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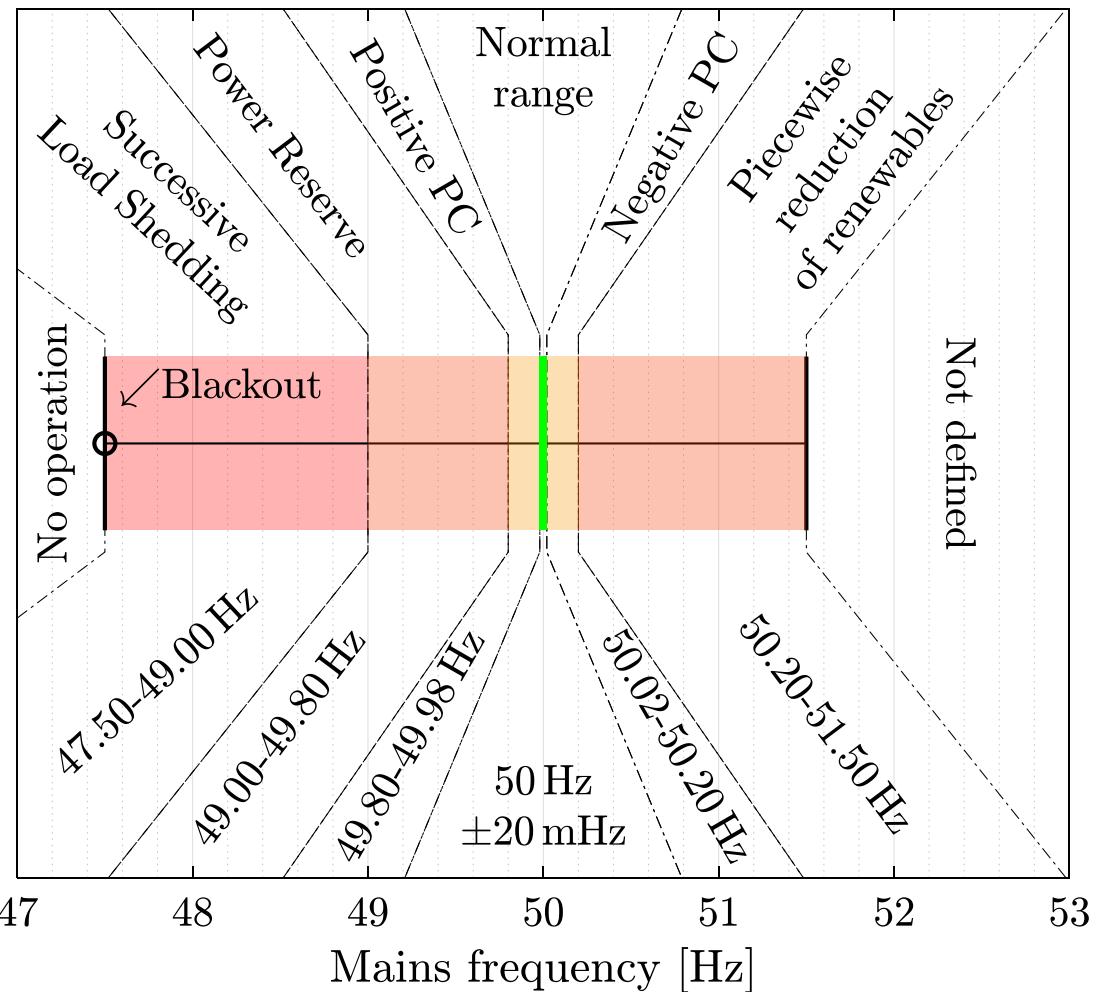
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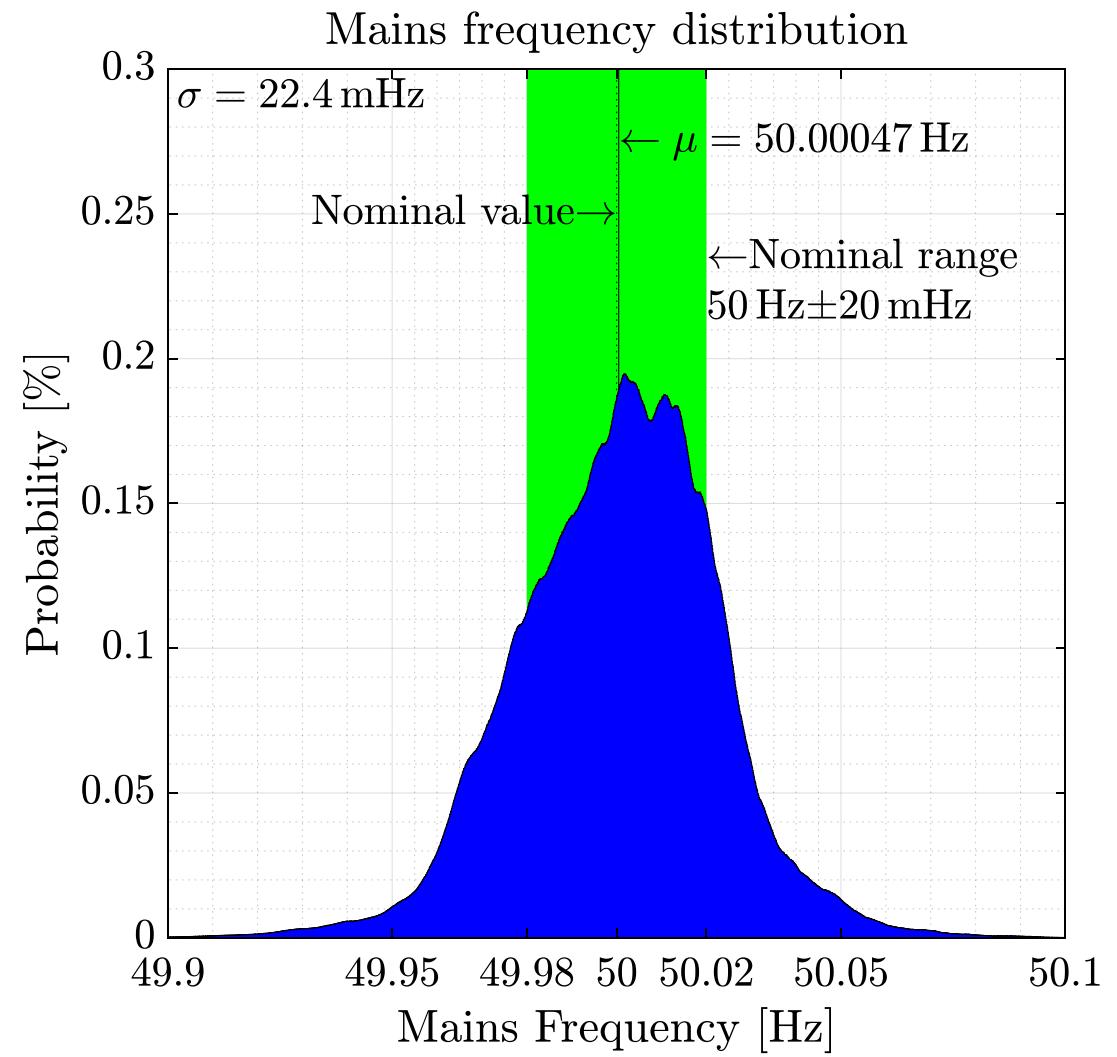
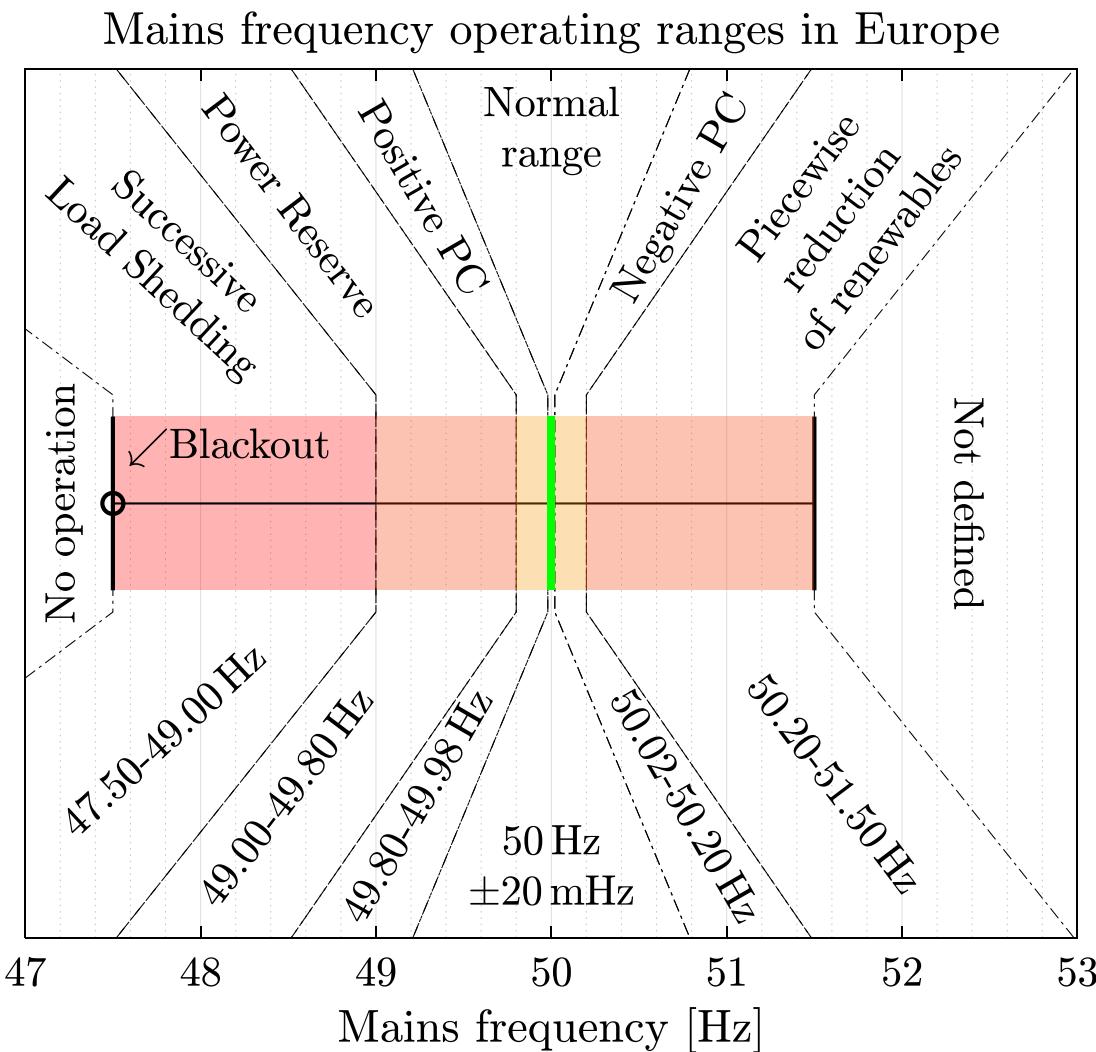


Mains frequency operating ranges

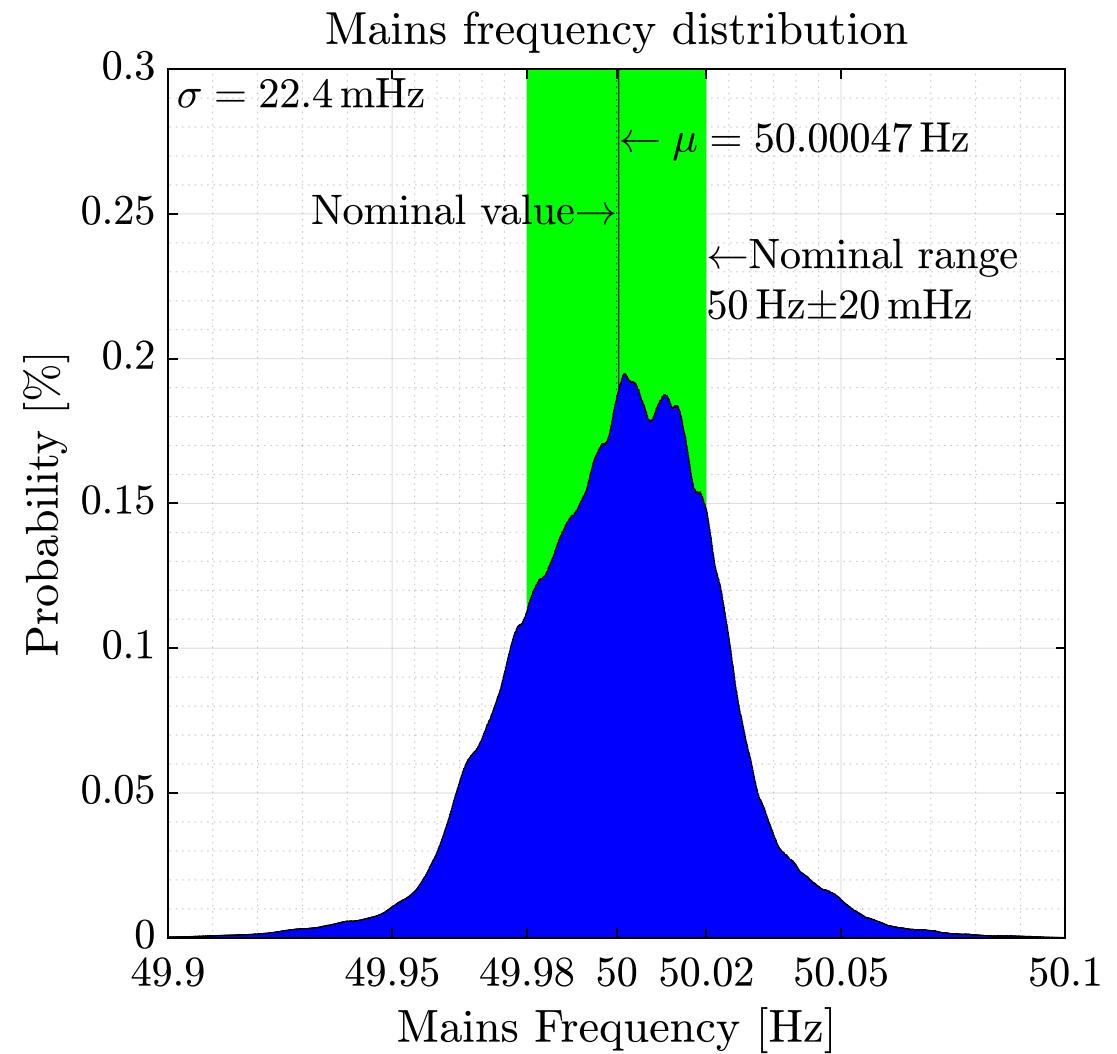
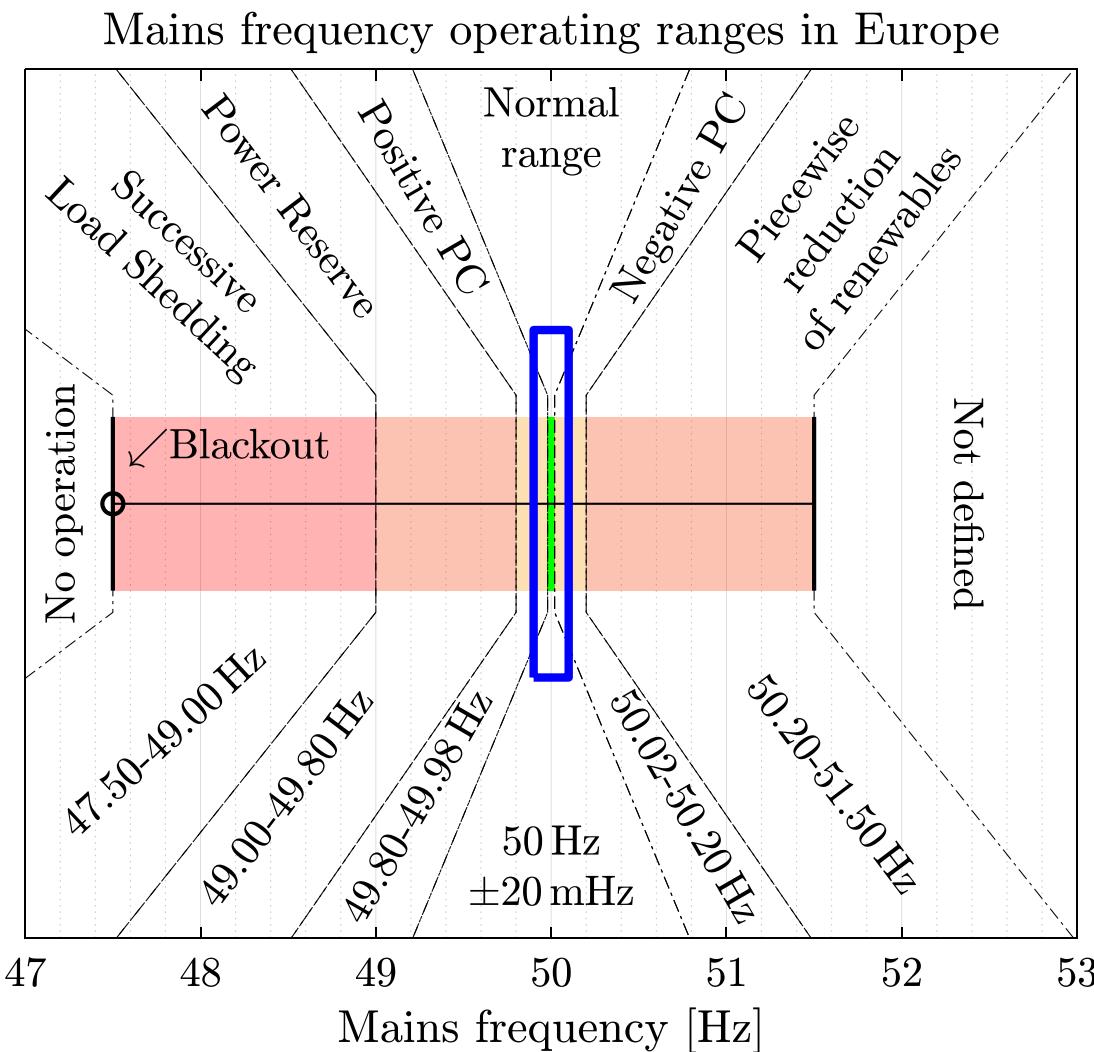
Mains frequency operating ranges in Europe



Mains frequency operating ranges

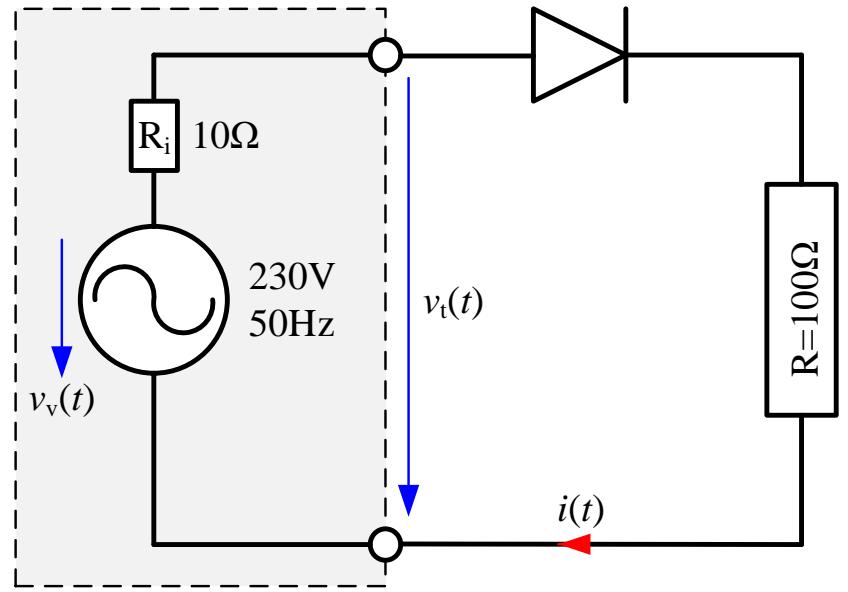


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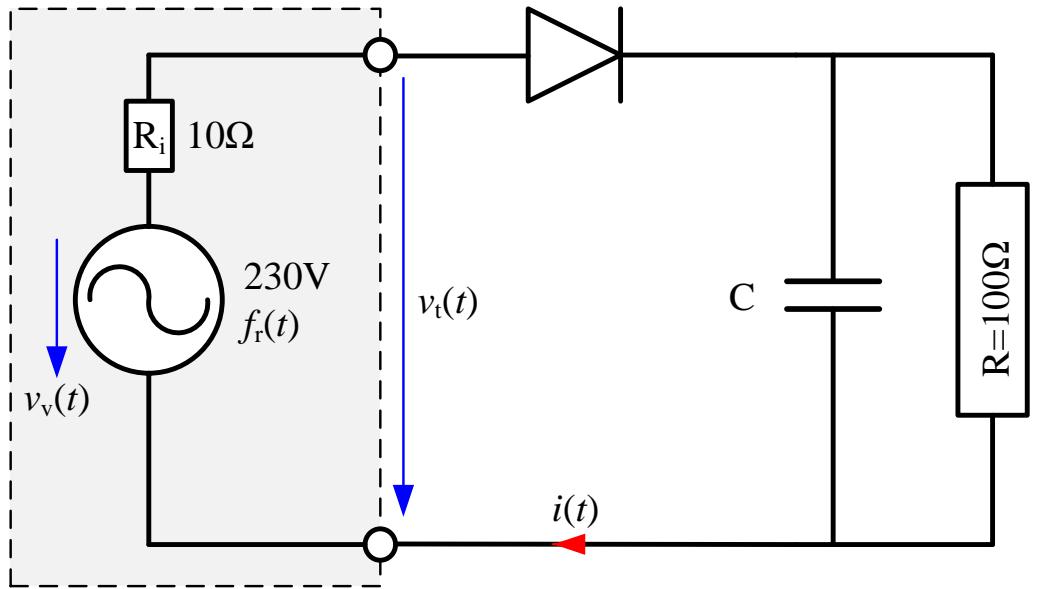


Measurements in Transient Conditions

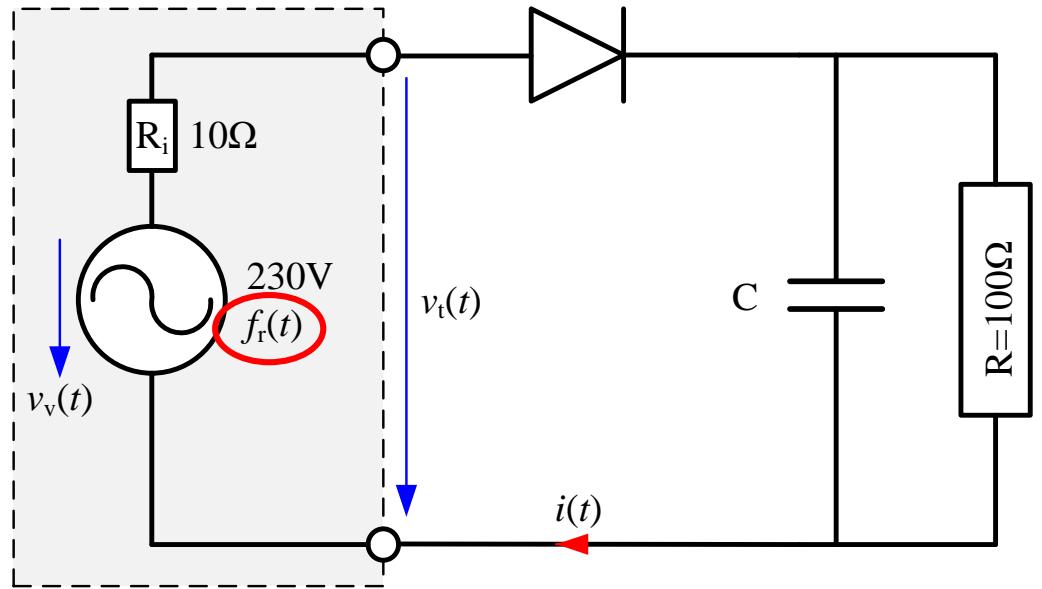
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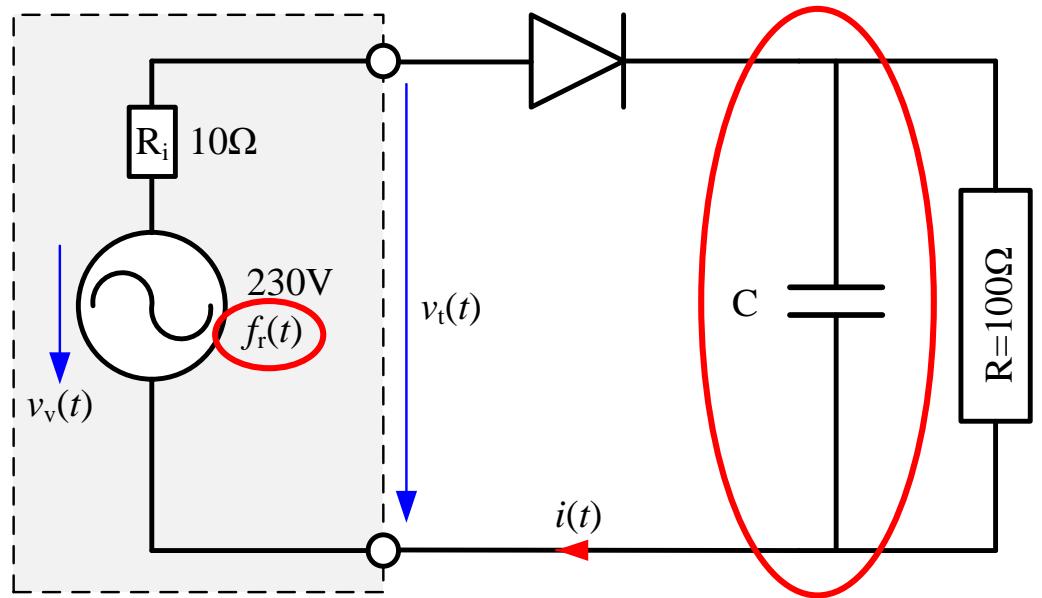
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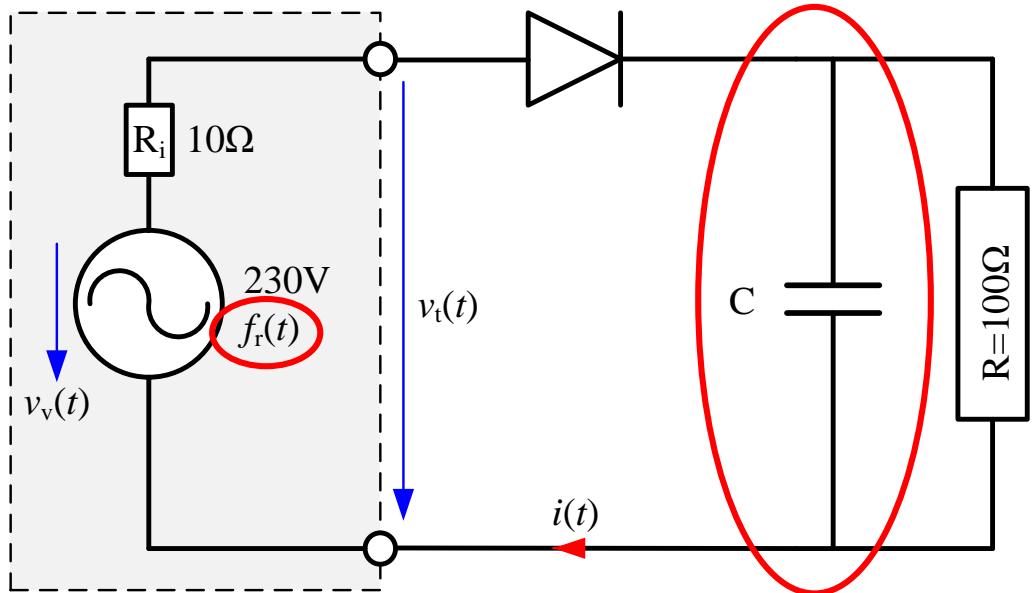


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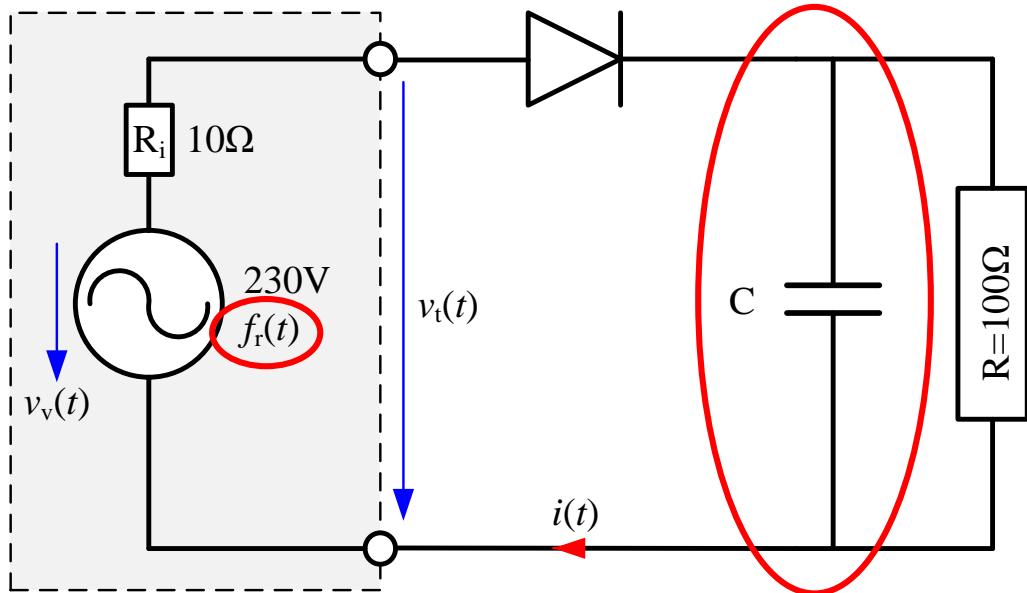


Measurements in Transient Conditions

- Harmonic voltage and current highly frequency dependent

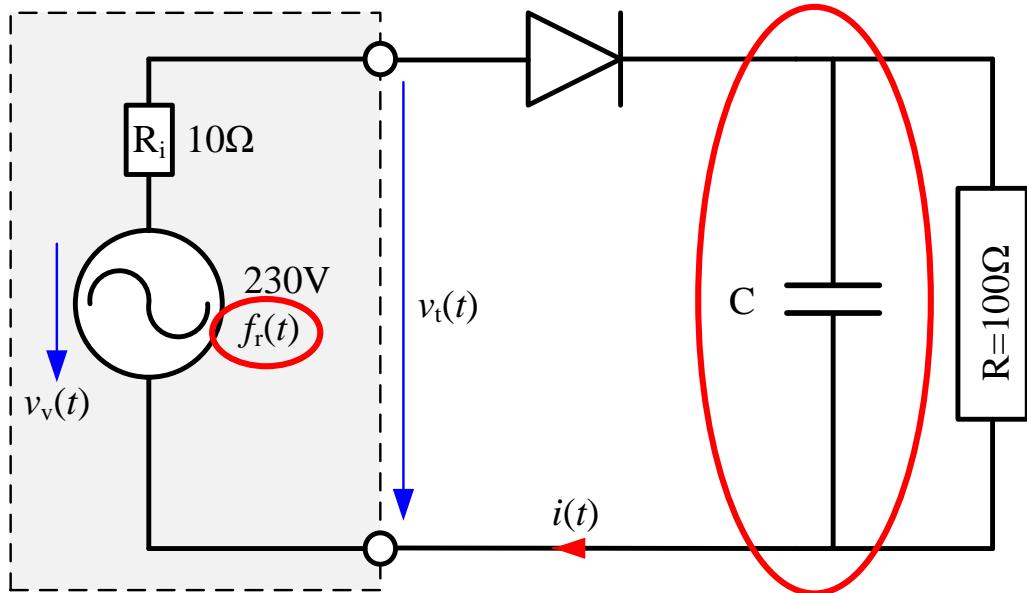


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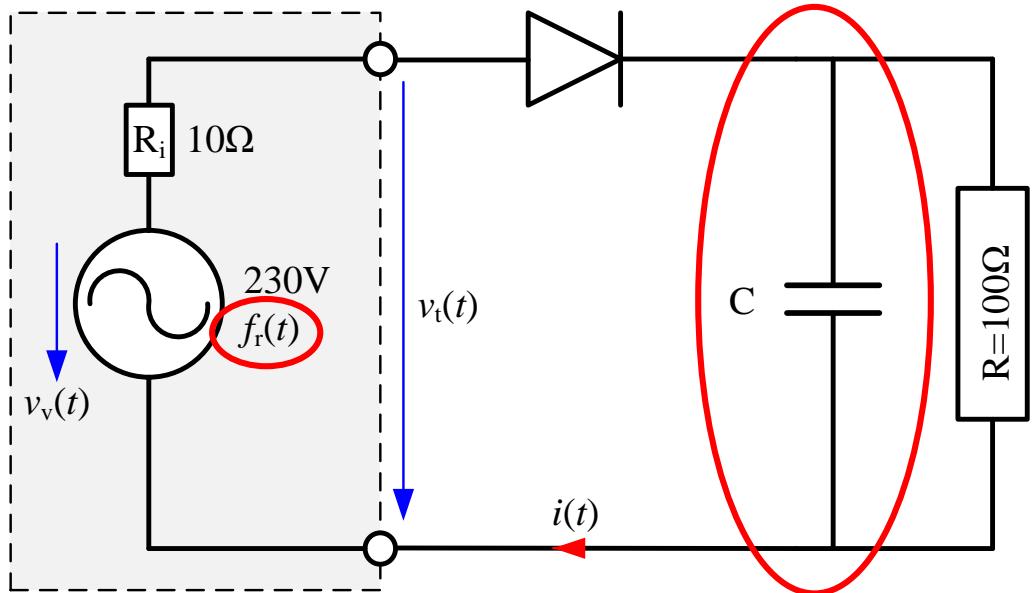
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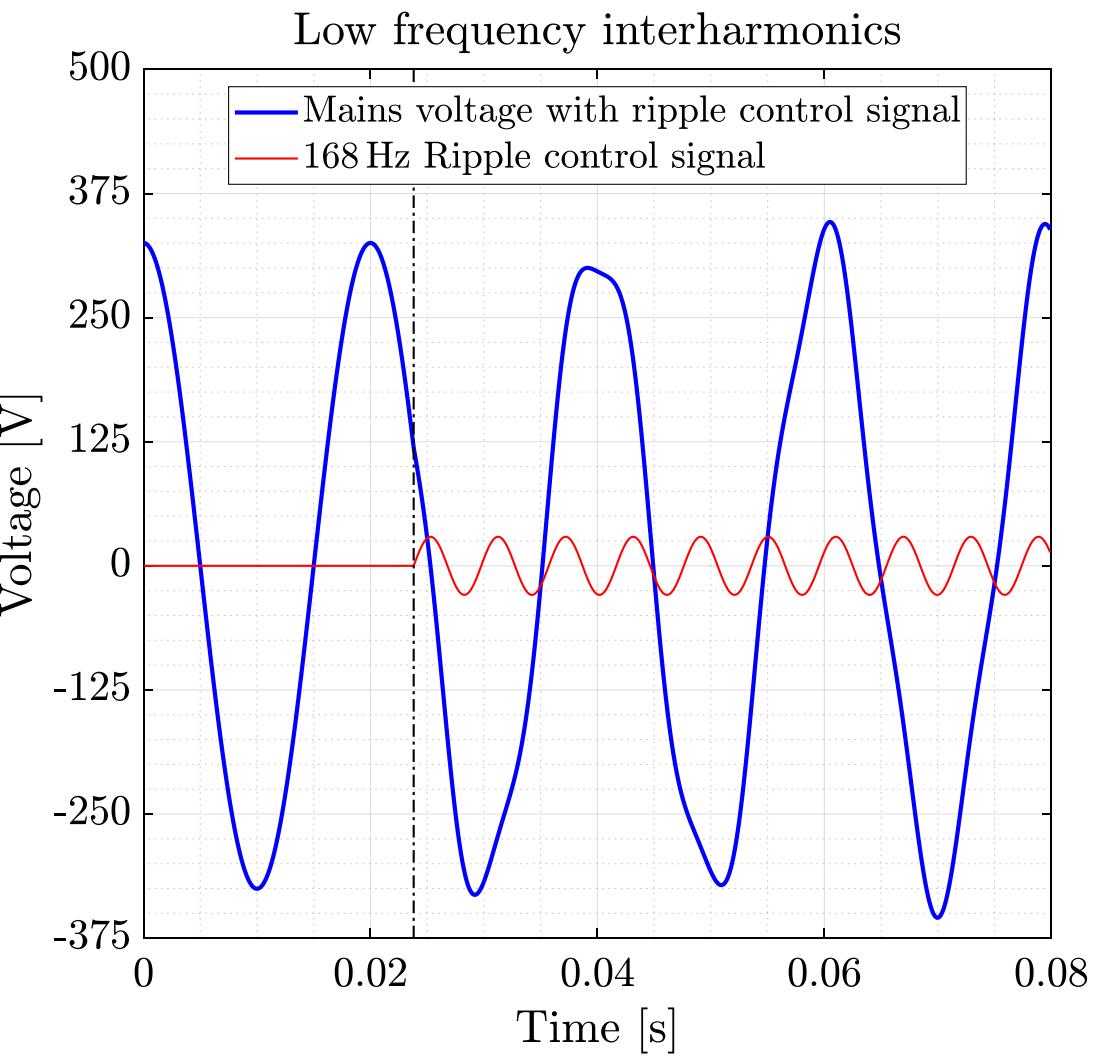
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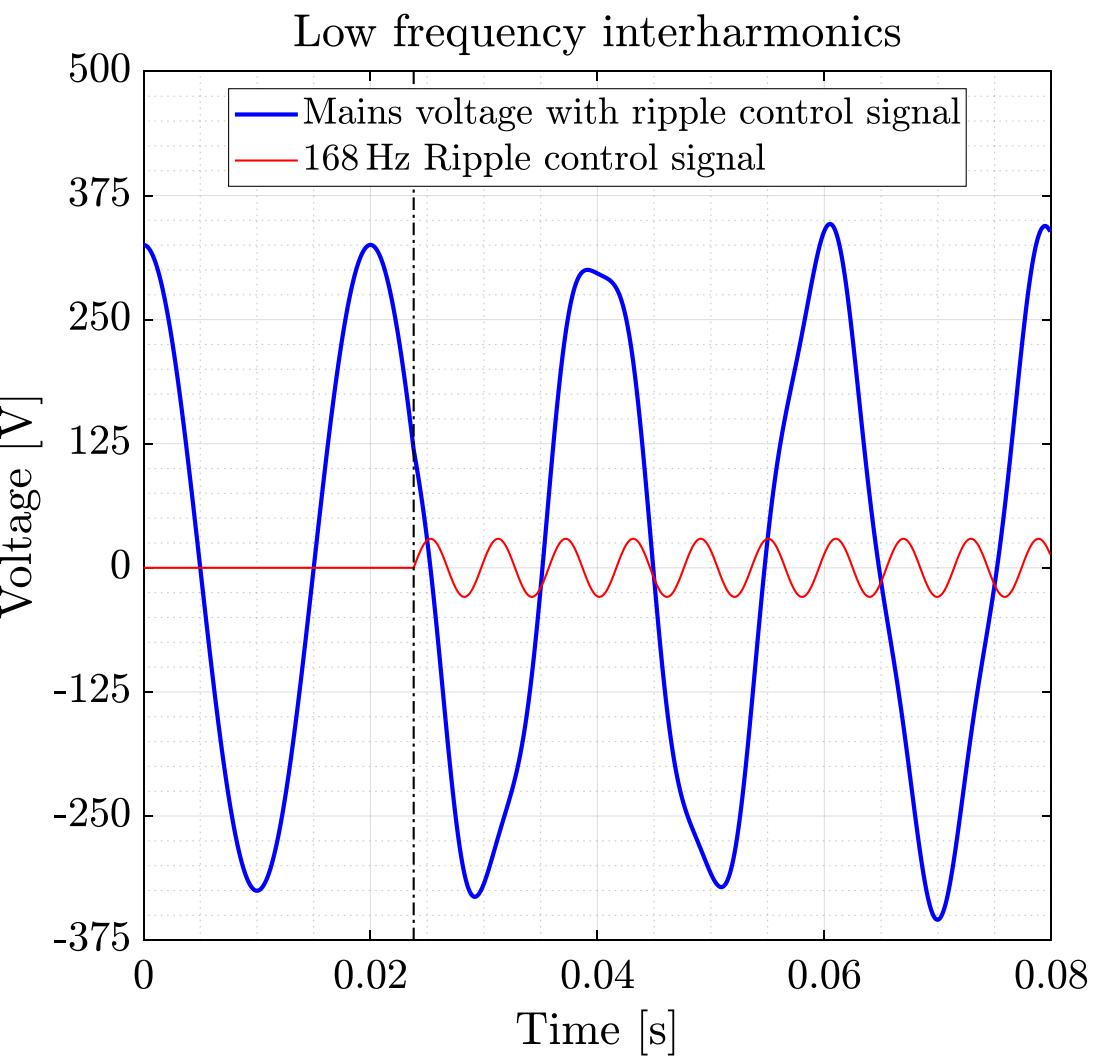
Metrological Challenges: External Influences

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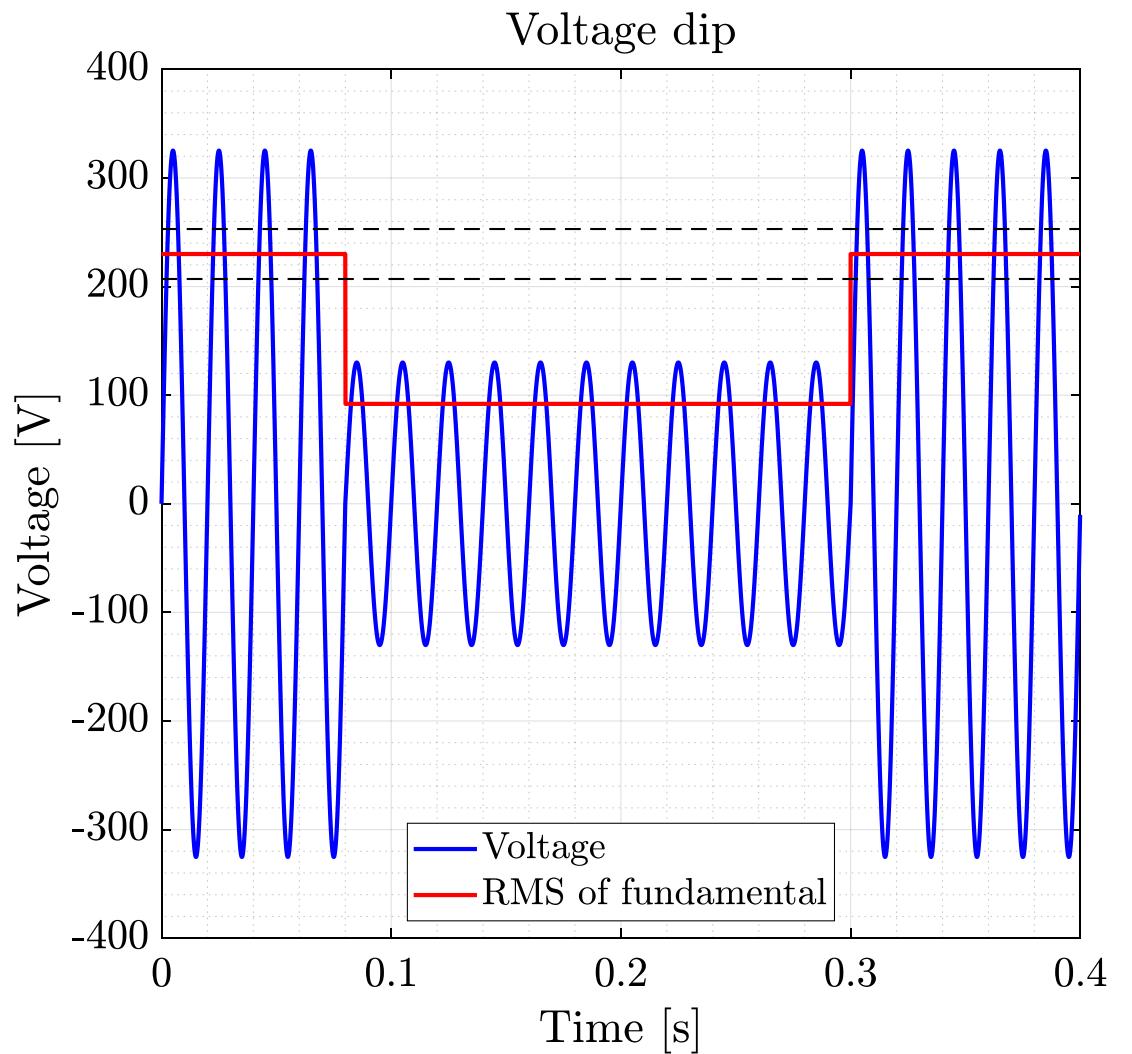
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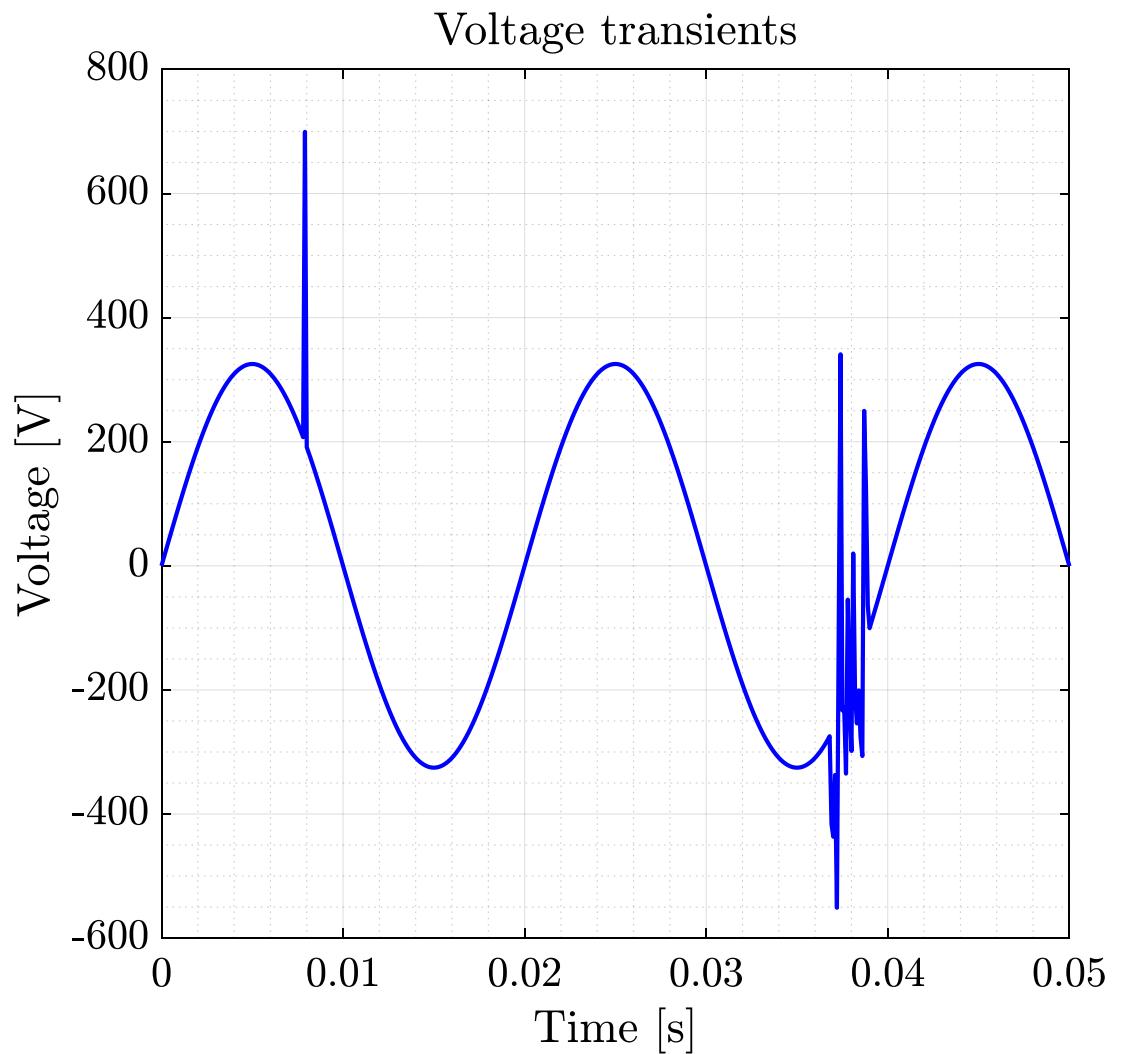
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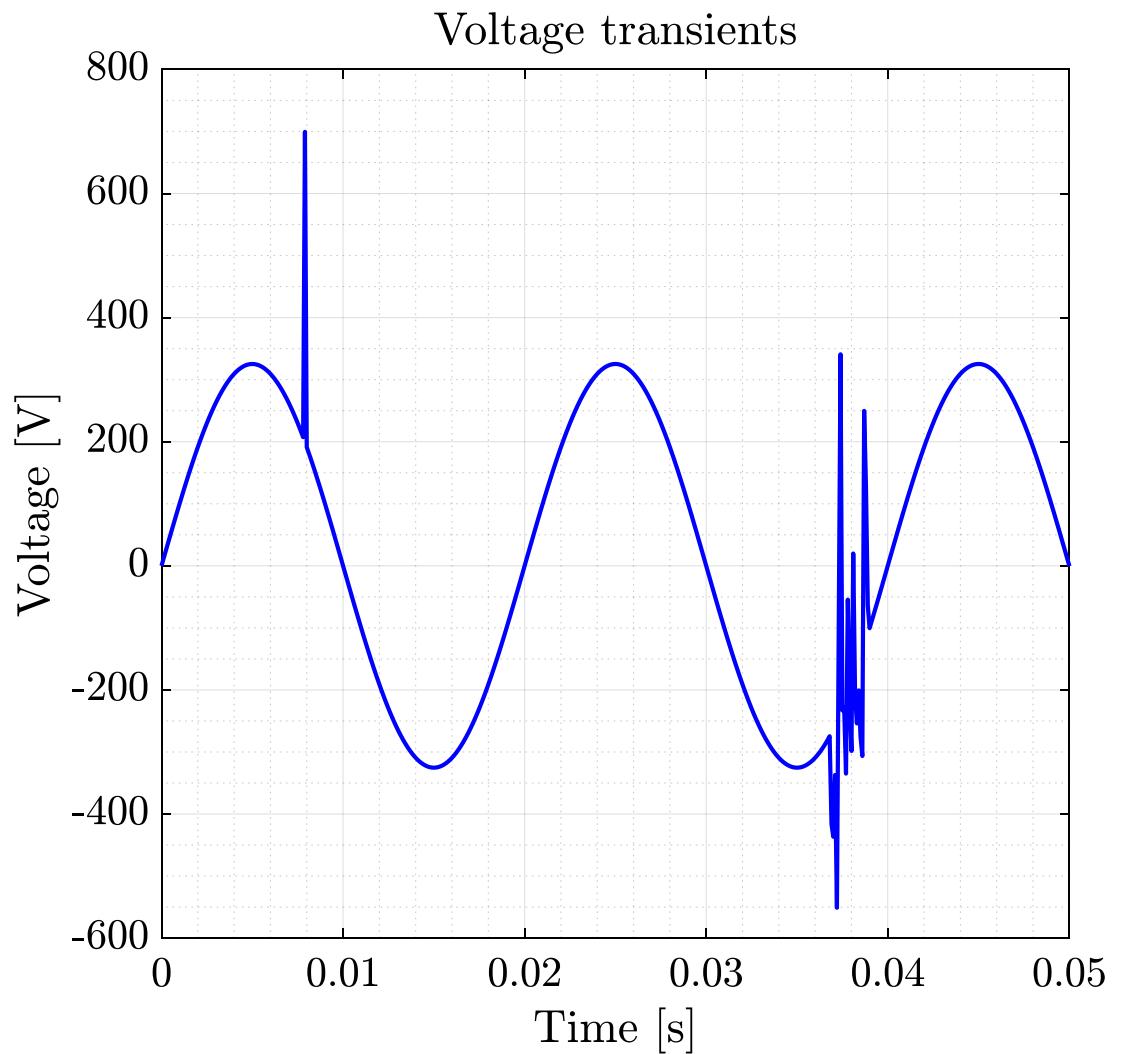
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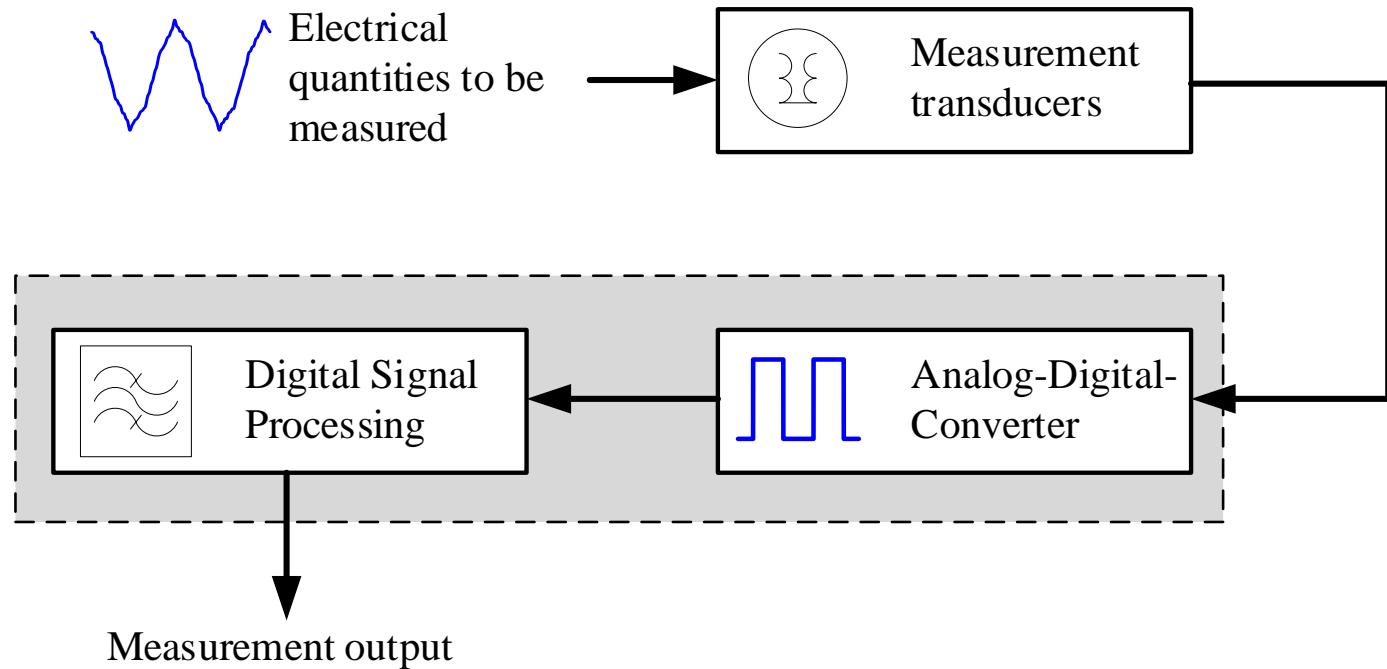
Metrological Challenges: External Influences

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- Deviations of the mains frequency

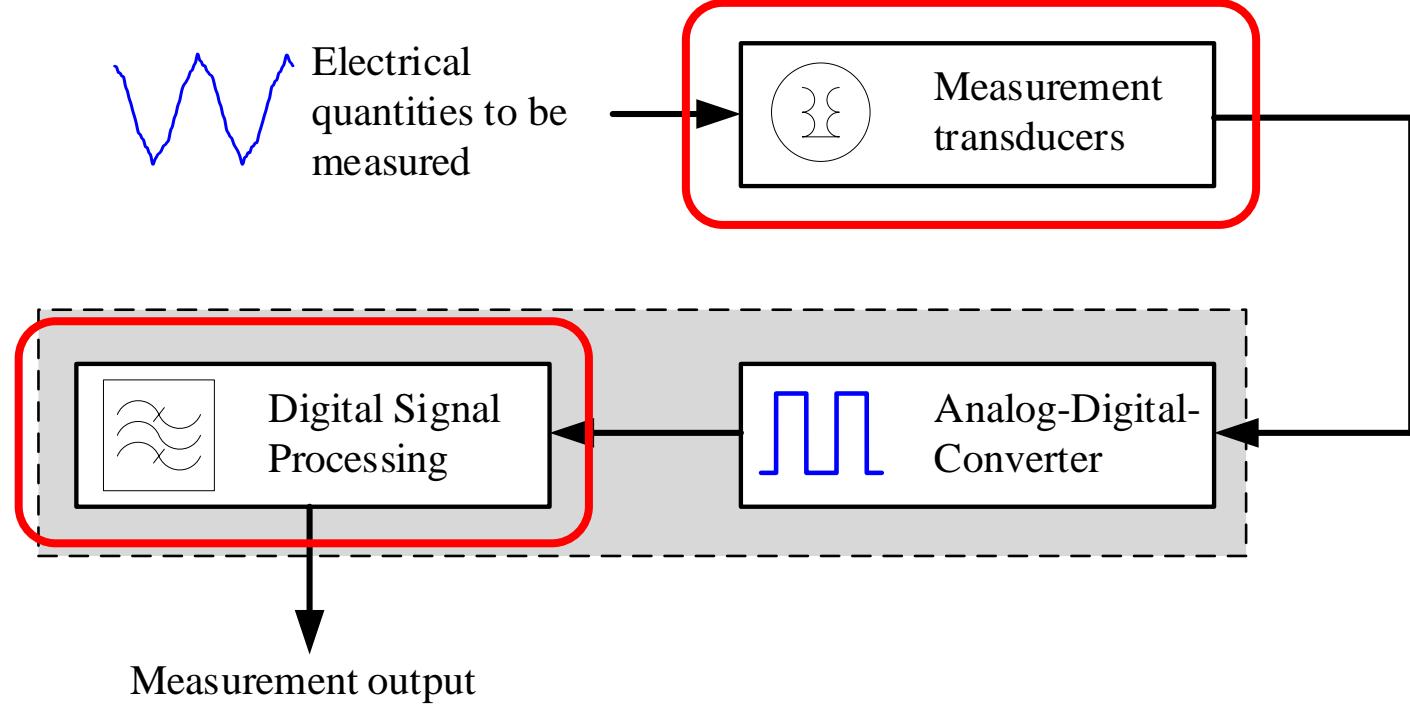


Metrological Challenges: The Measurement Chain

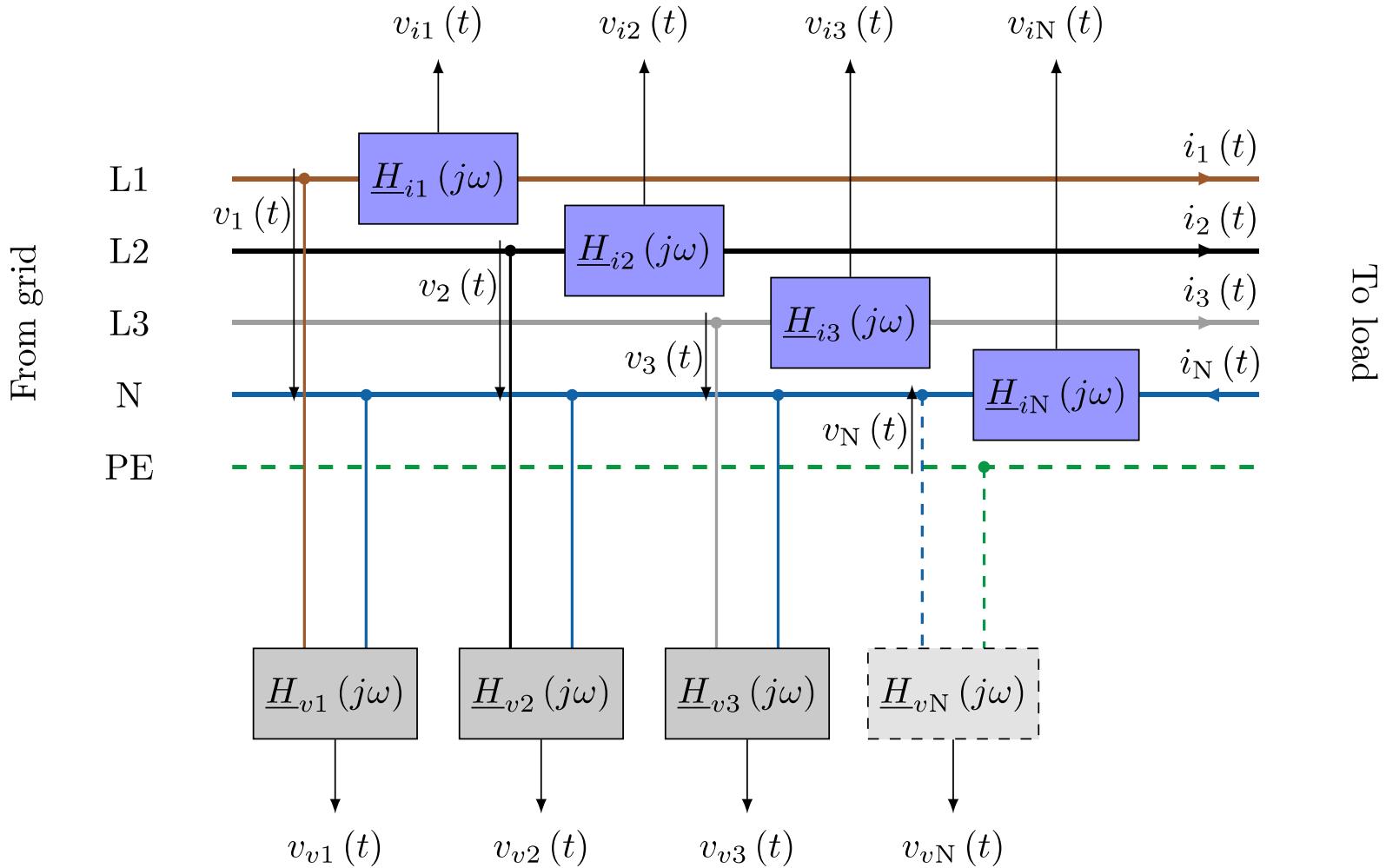
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Metrological Challenges: Characterization of measurement transducers



Metrological Challenges: Digital Spectral Analysis

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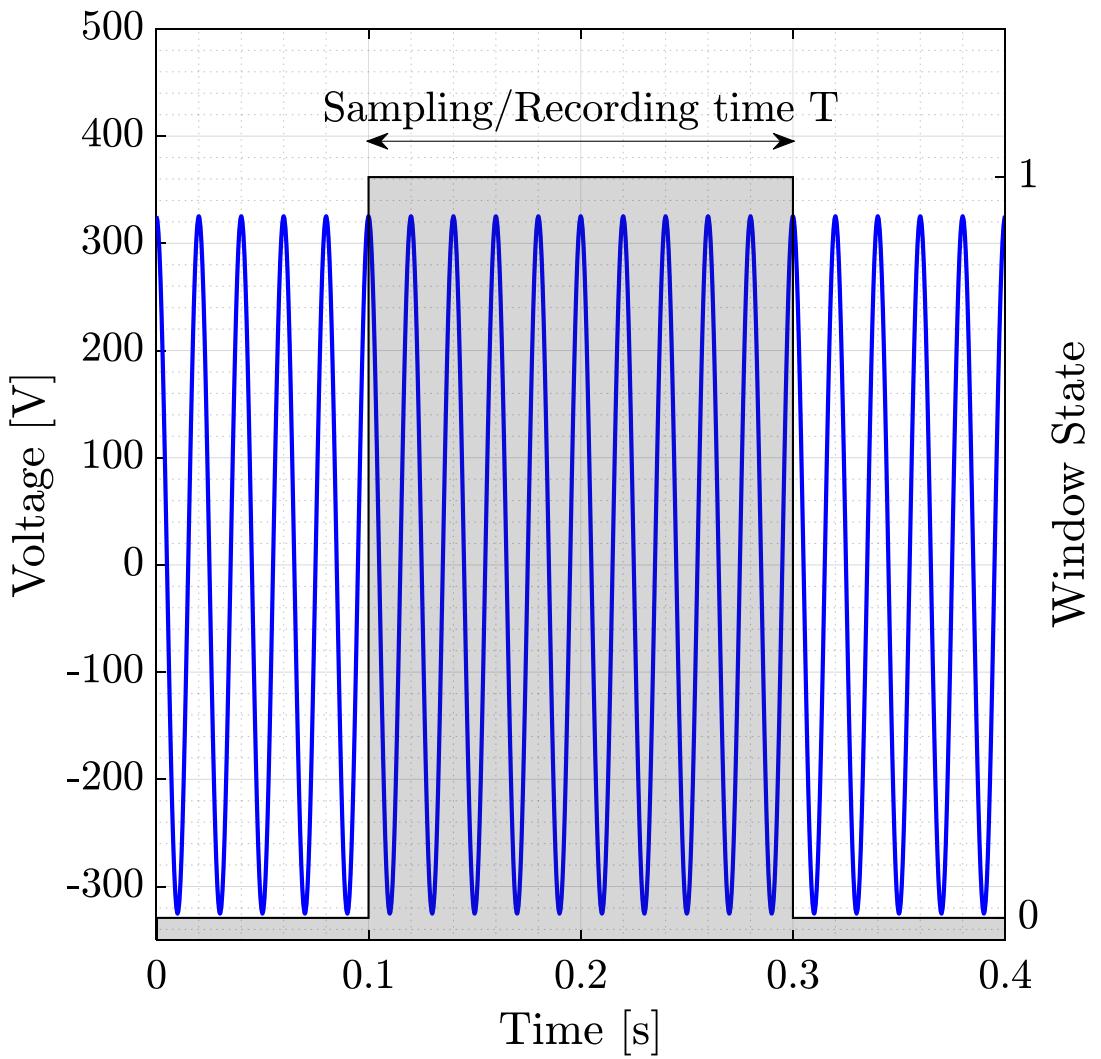


$$v[n] \longrightarrow V[m] = \frac{1}{N} \sum_{n=0}^{N-1} v[n] \cdot e^{-j2\pi \frac{mn}{N}}$$

Metrological Challenges: Digital Spectral Analysis

- Discrete Fourier Transform instead of Fourier Series
- Multiplication with rectangular window
 - Spectral resolution

$$\Delta f = \frac{1}{T}$$

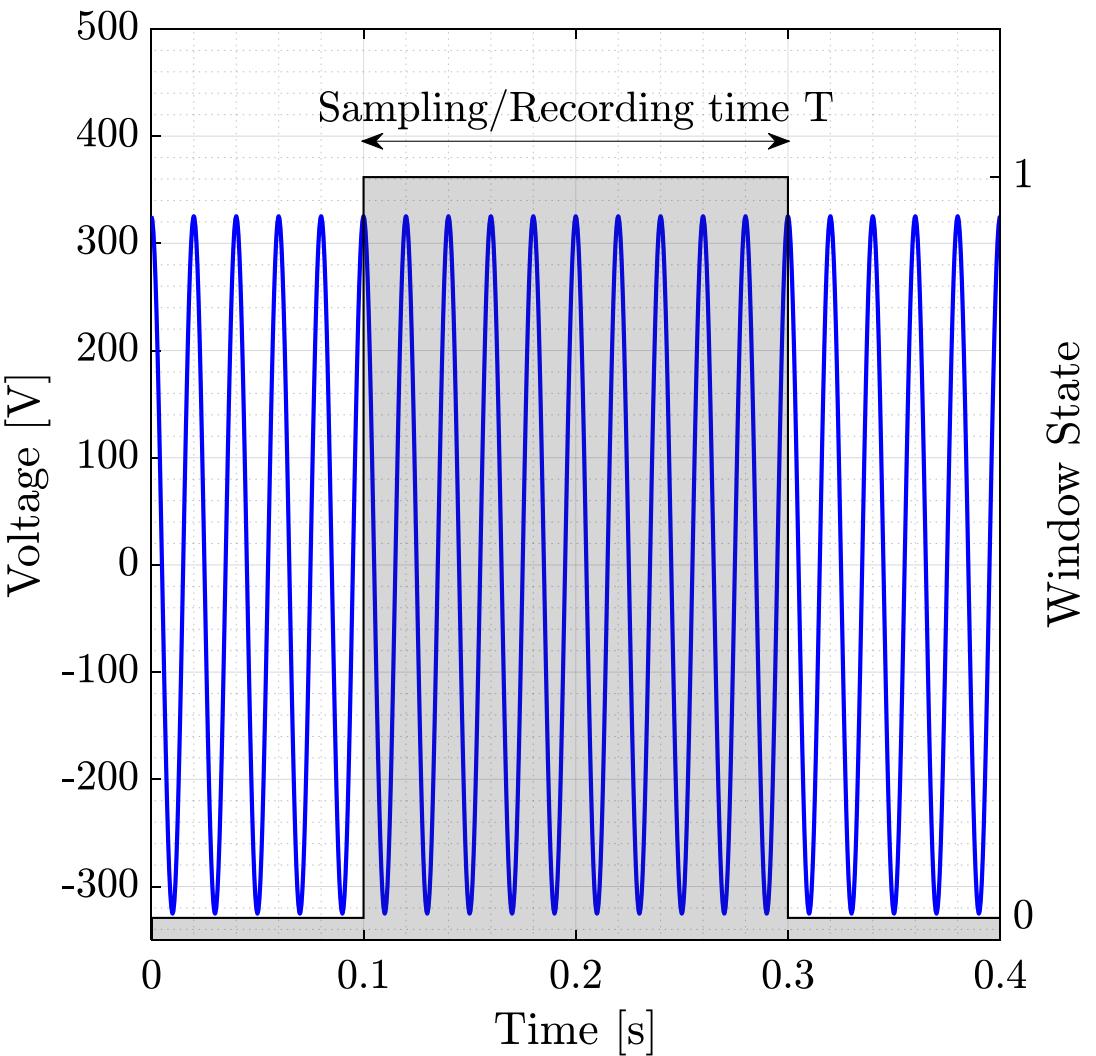


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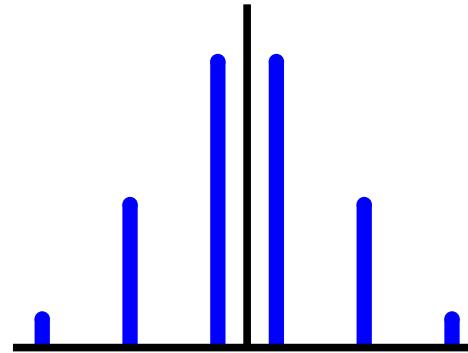
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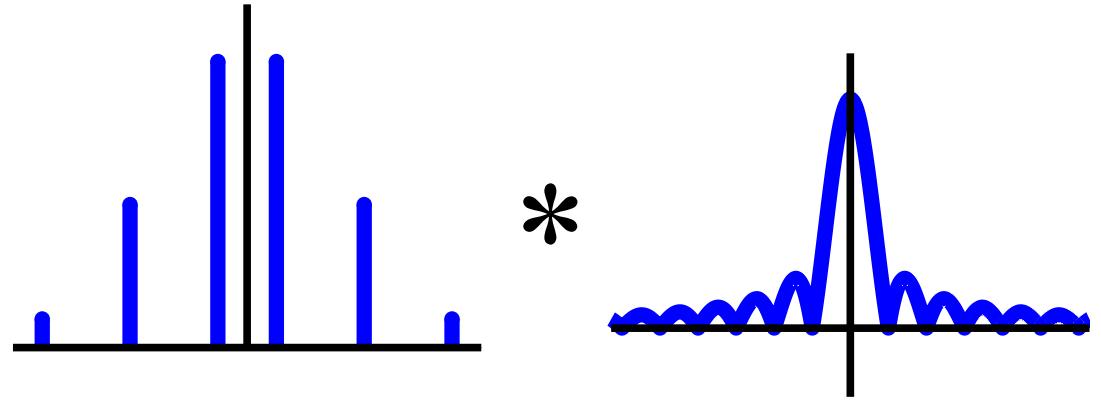
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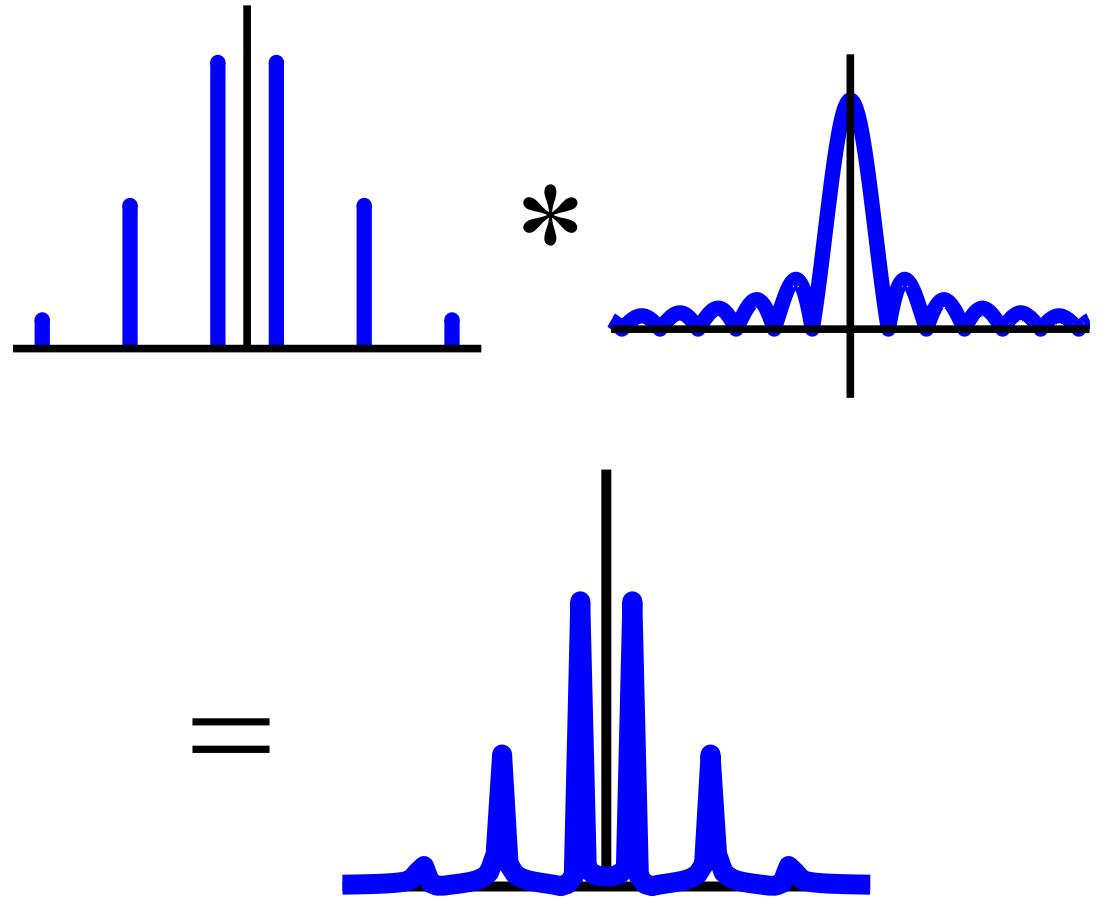
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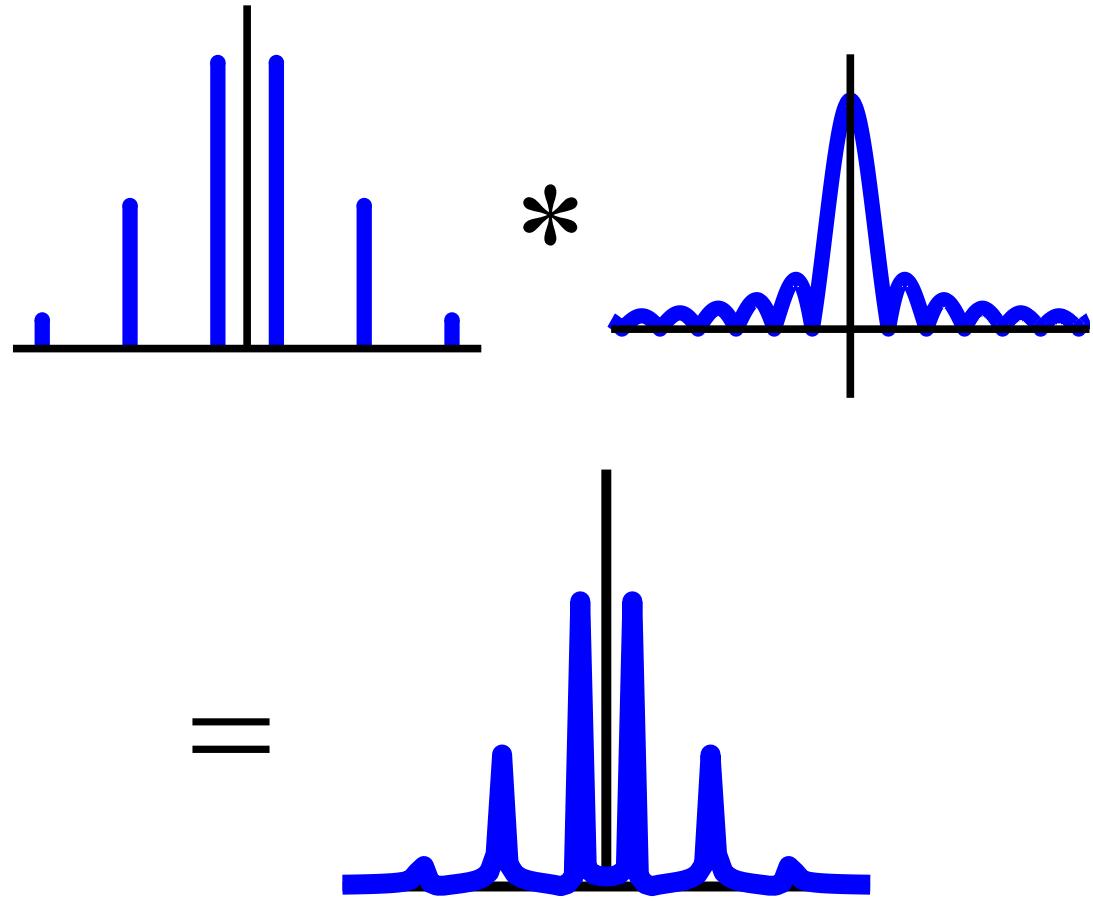
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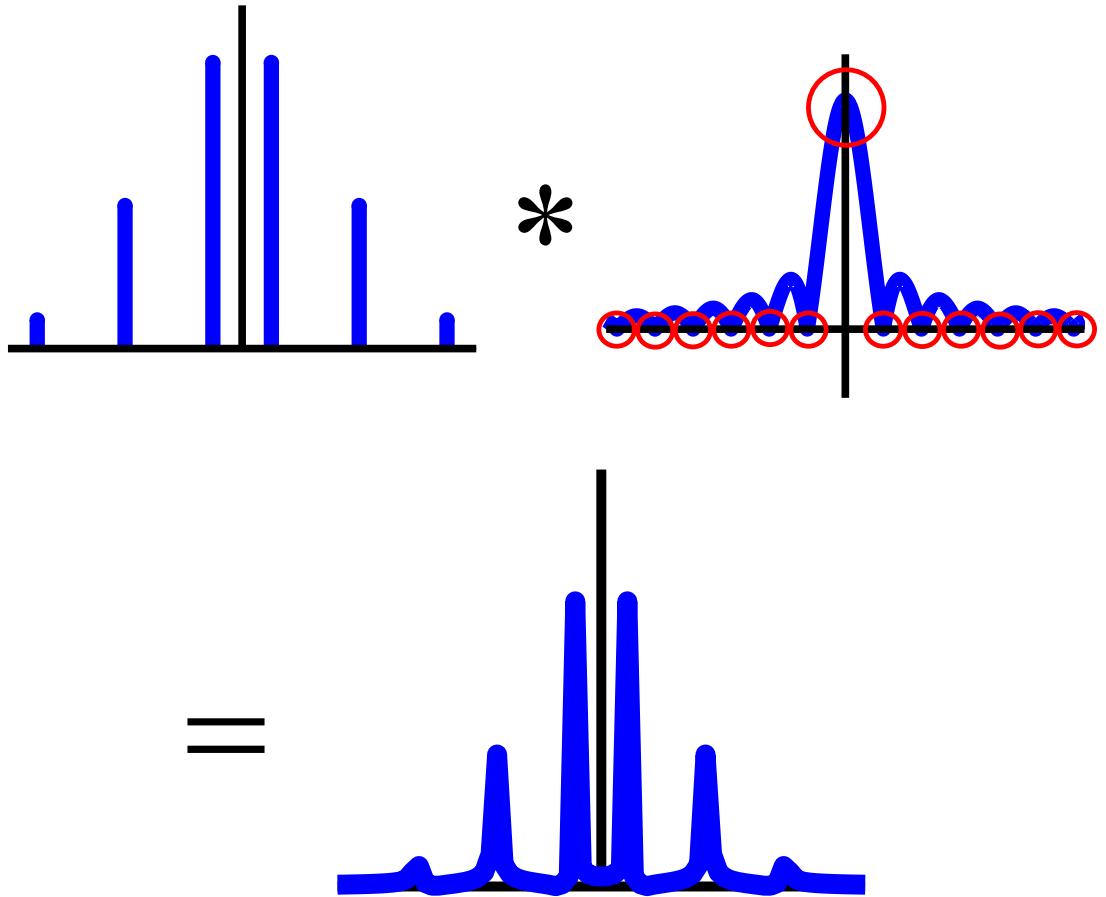
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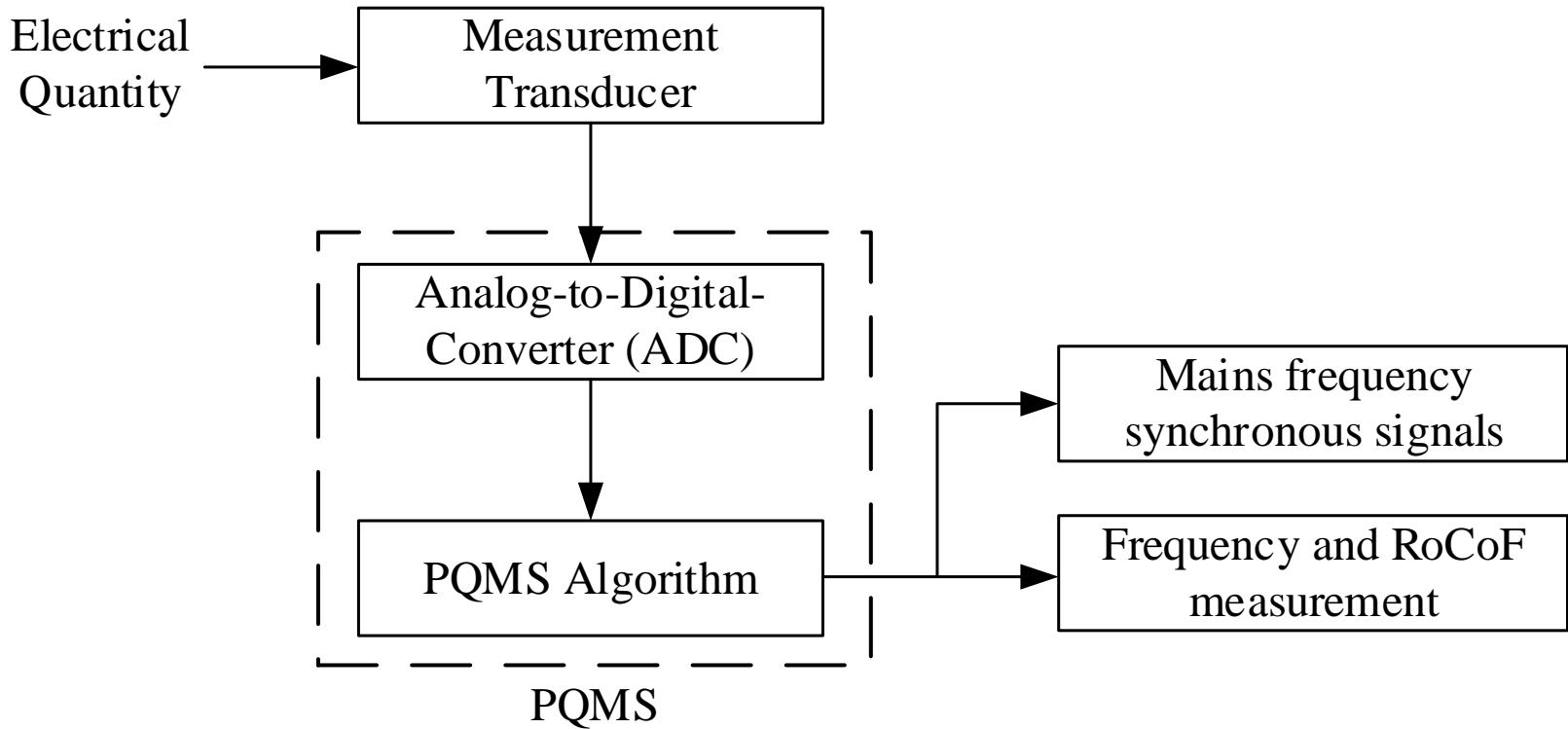
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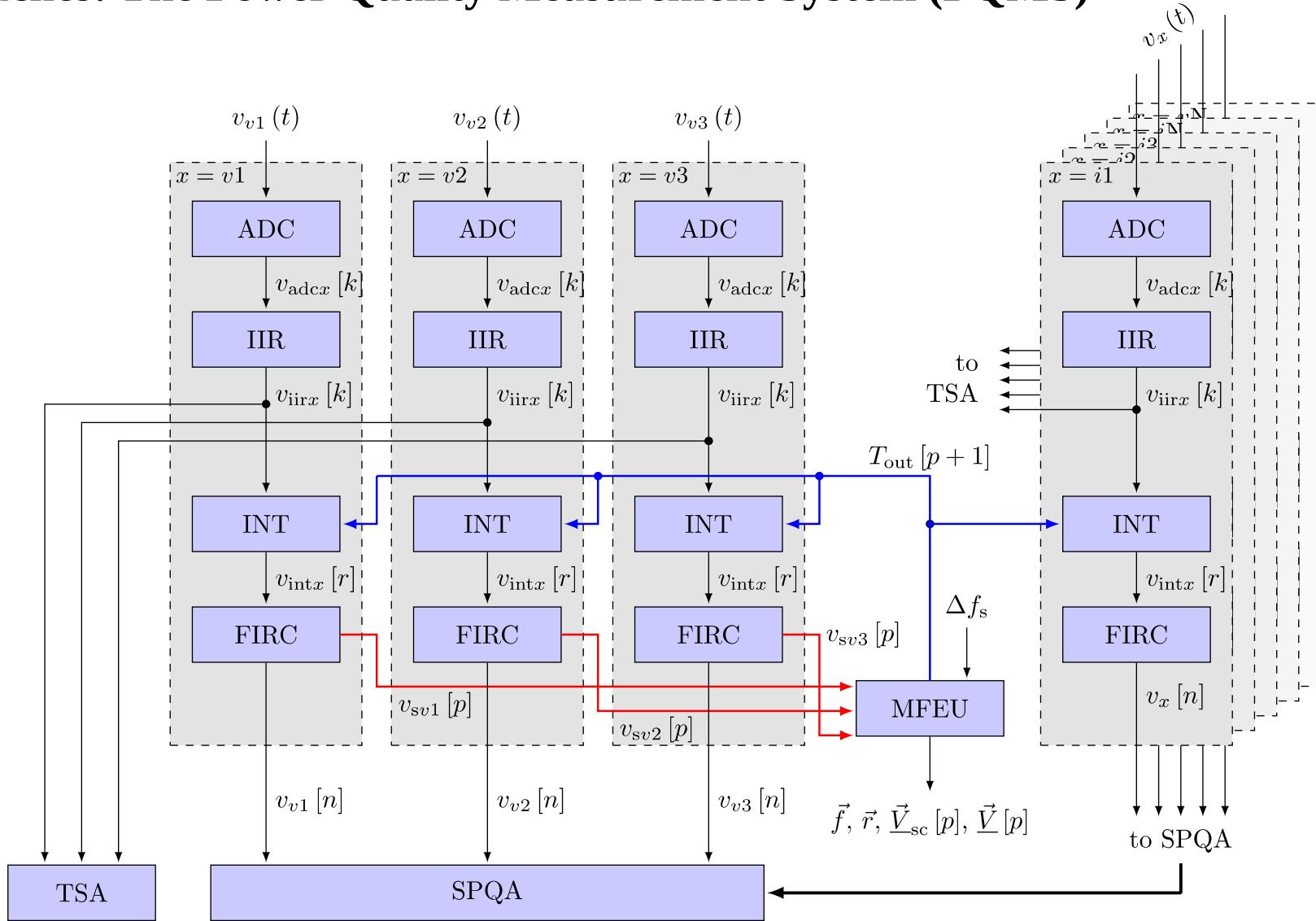
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- Synchronization of T with notches in spectrum of rectangular window



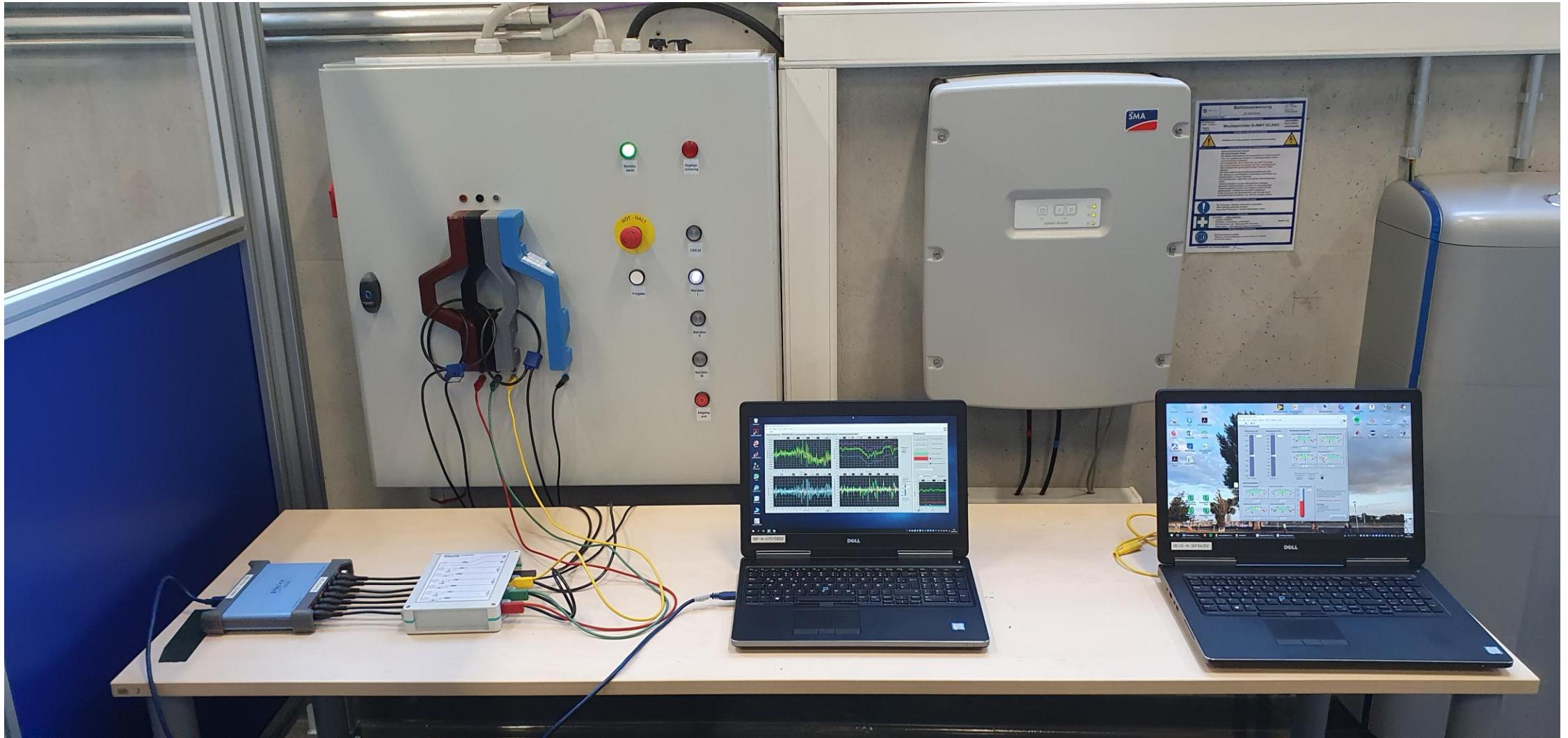
New Approaches: The Power Quality Measurement System (PQMS)



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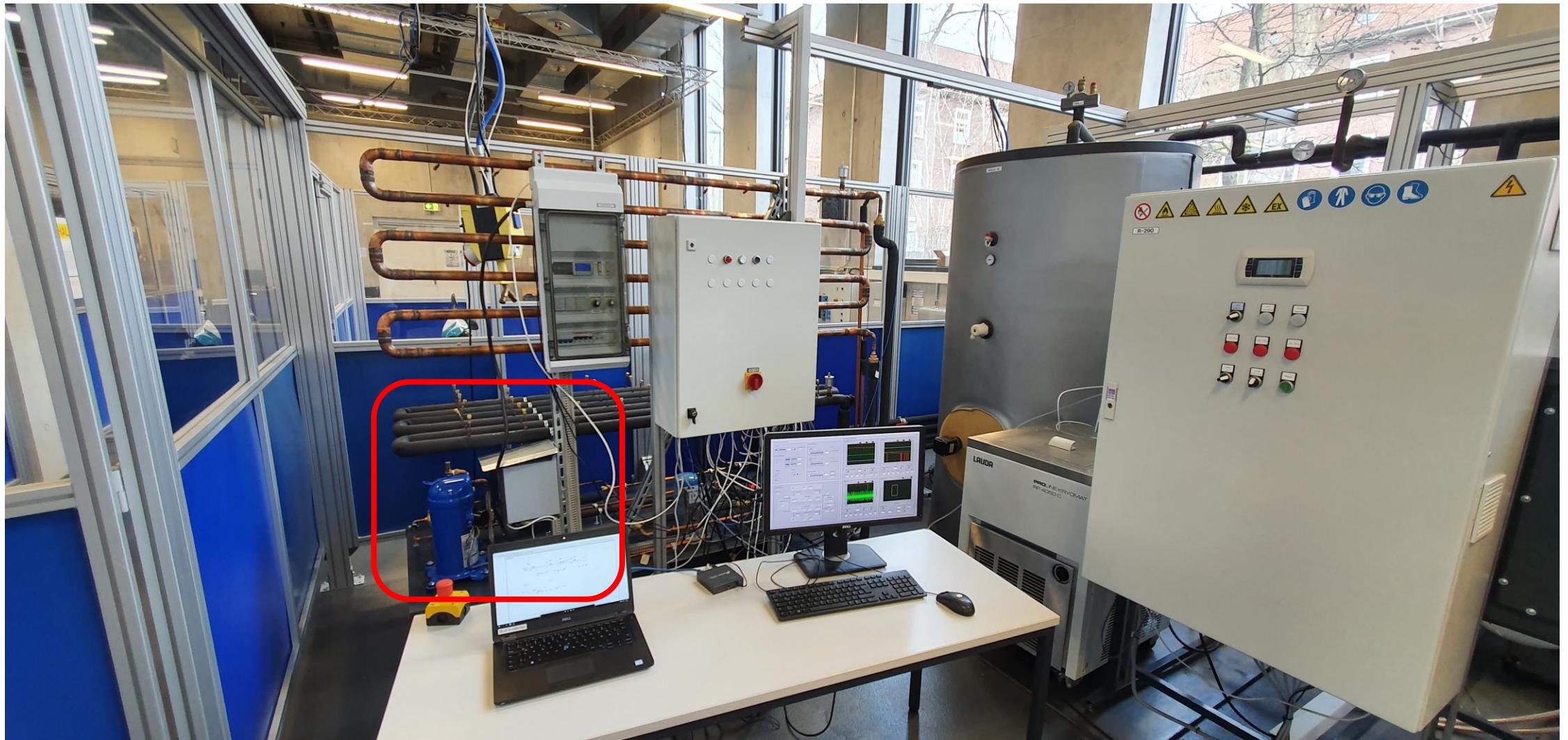
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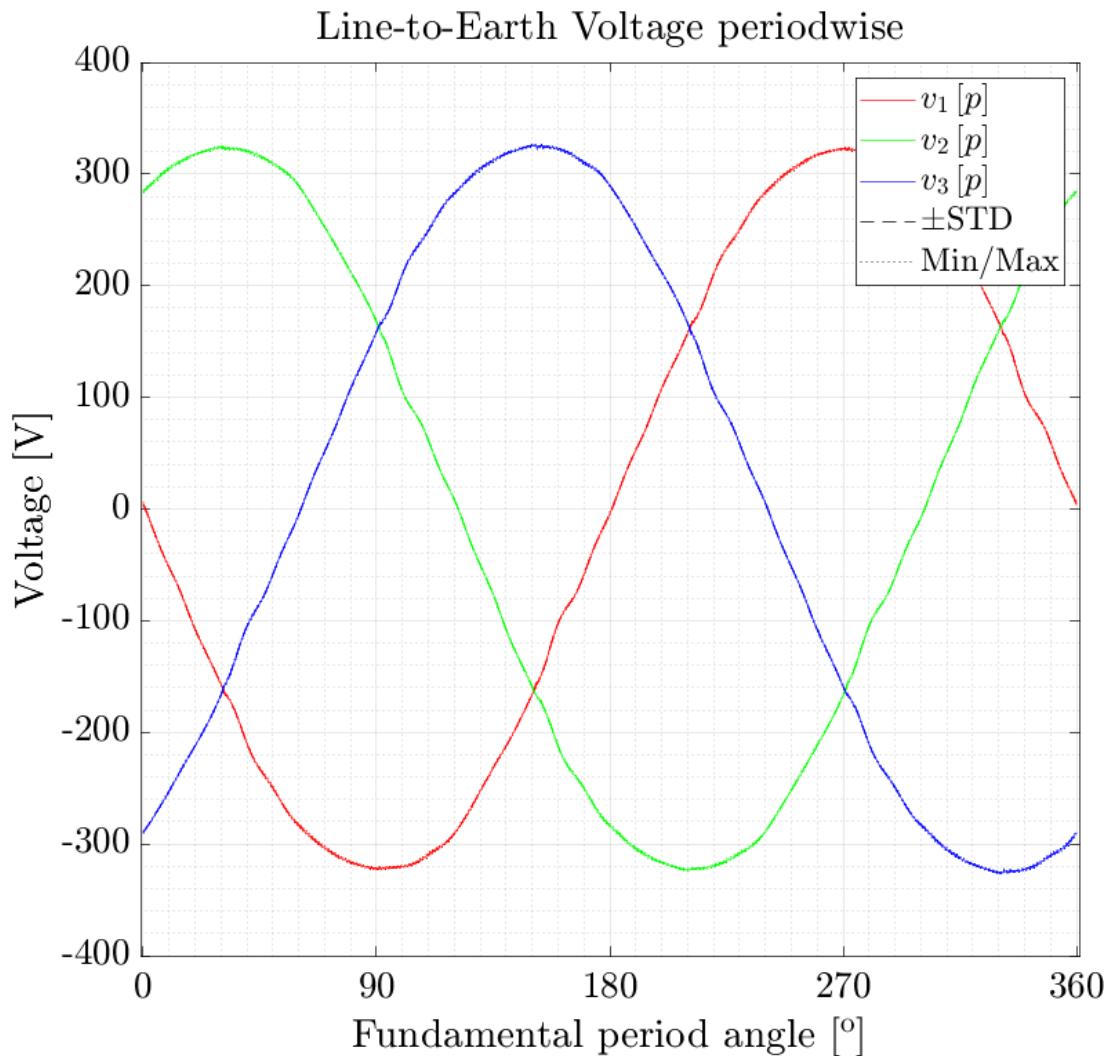


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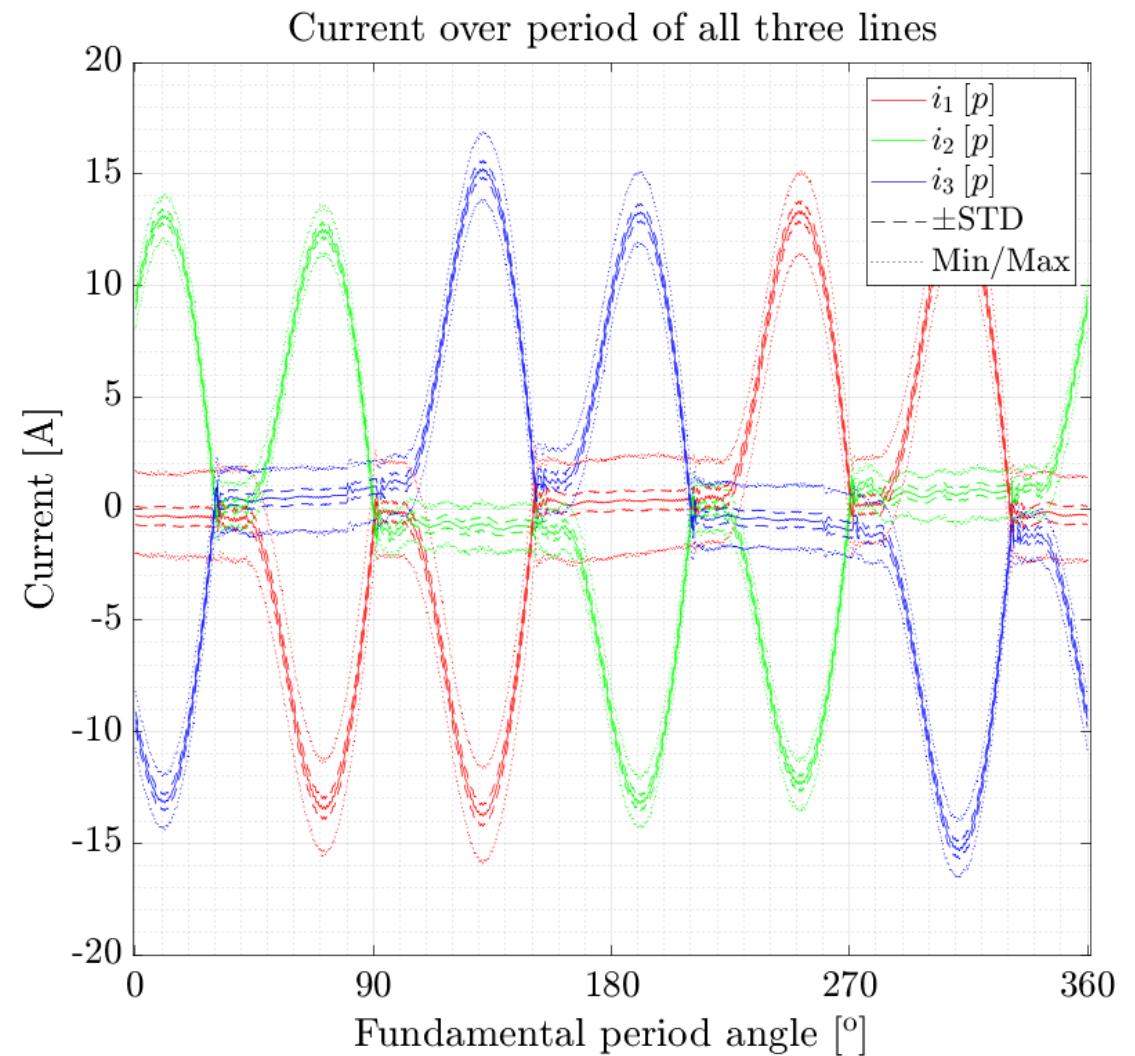
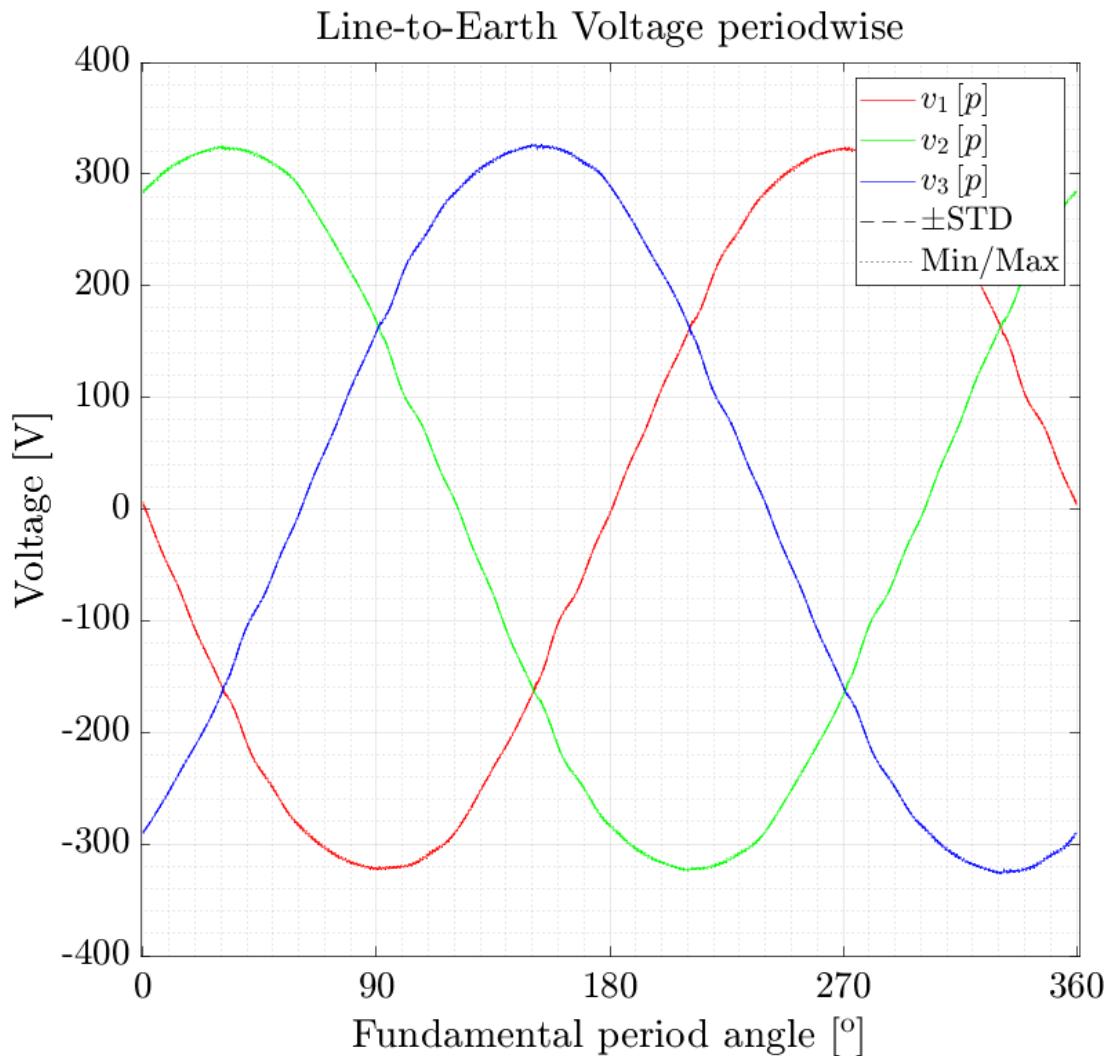


Measurements: Voltage and Current over time

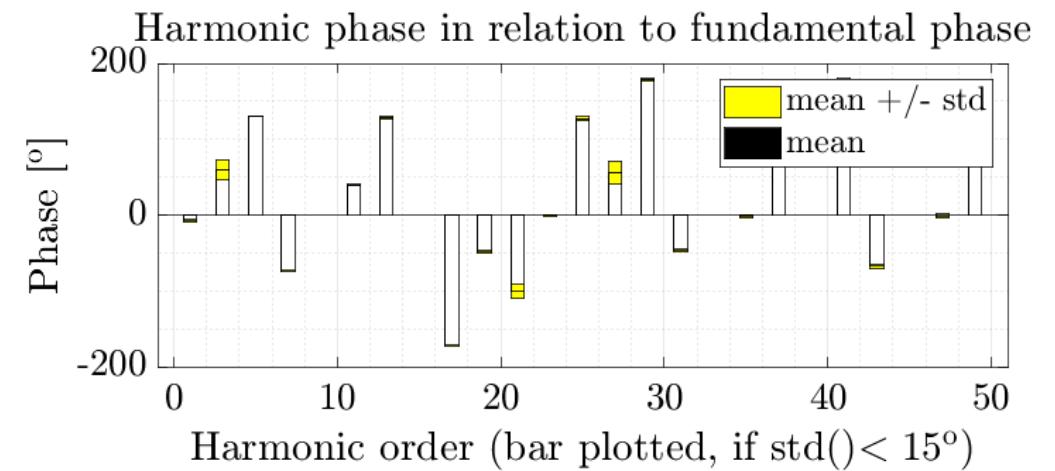
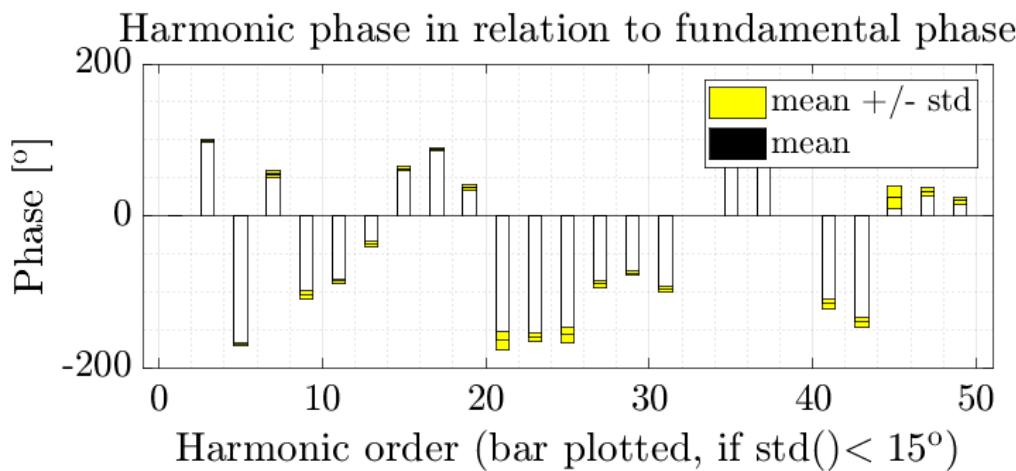
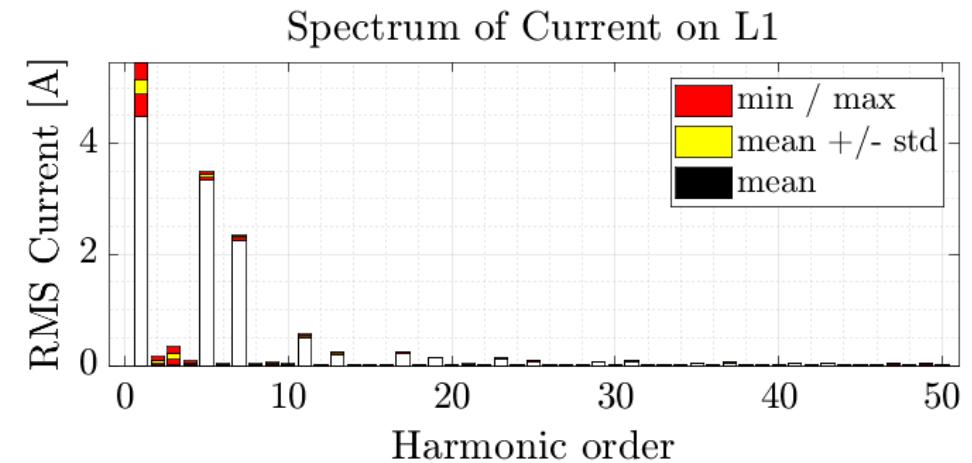
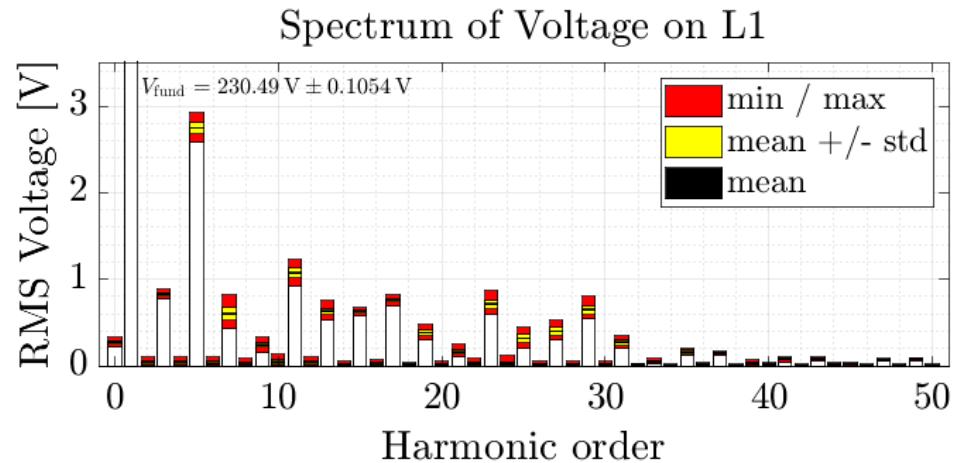
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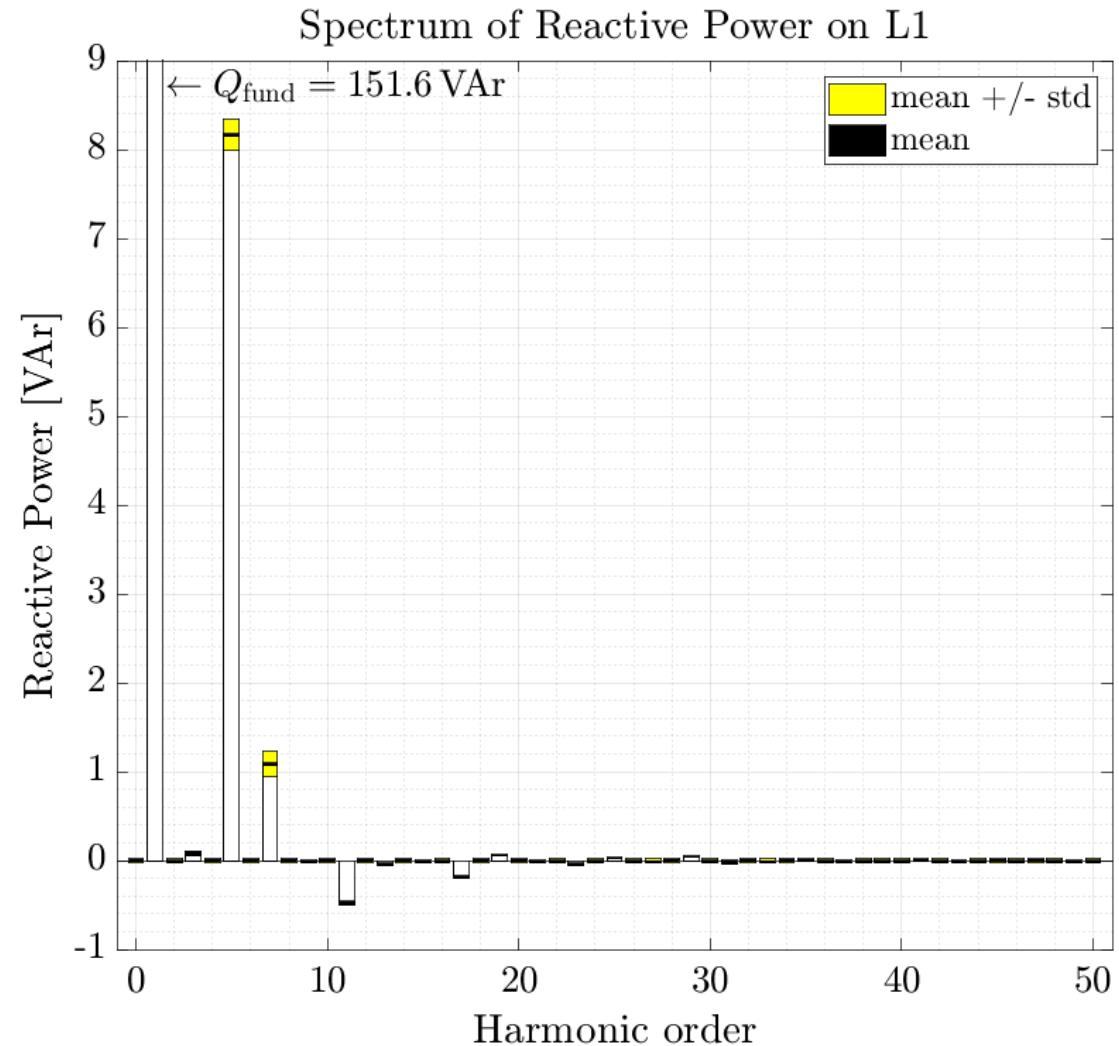
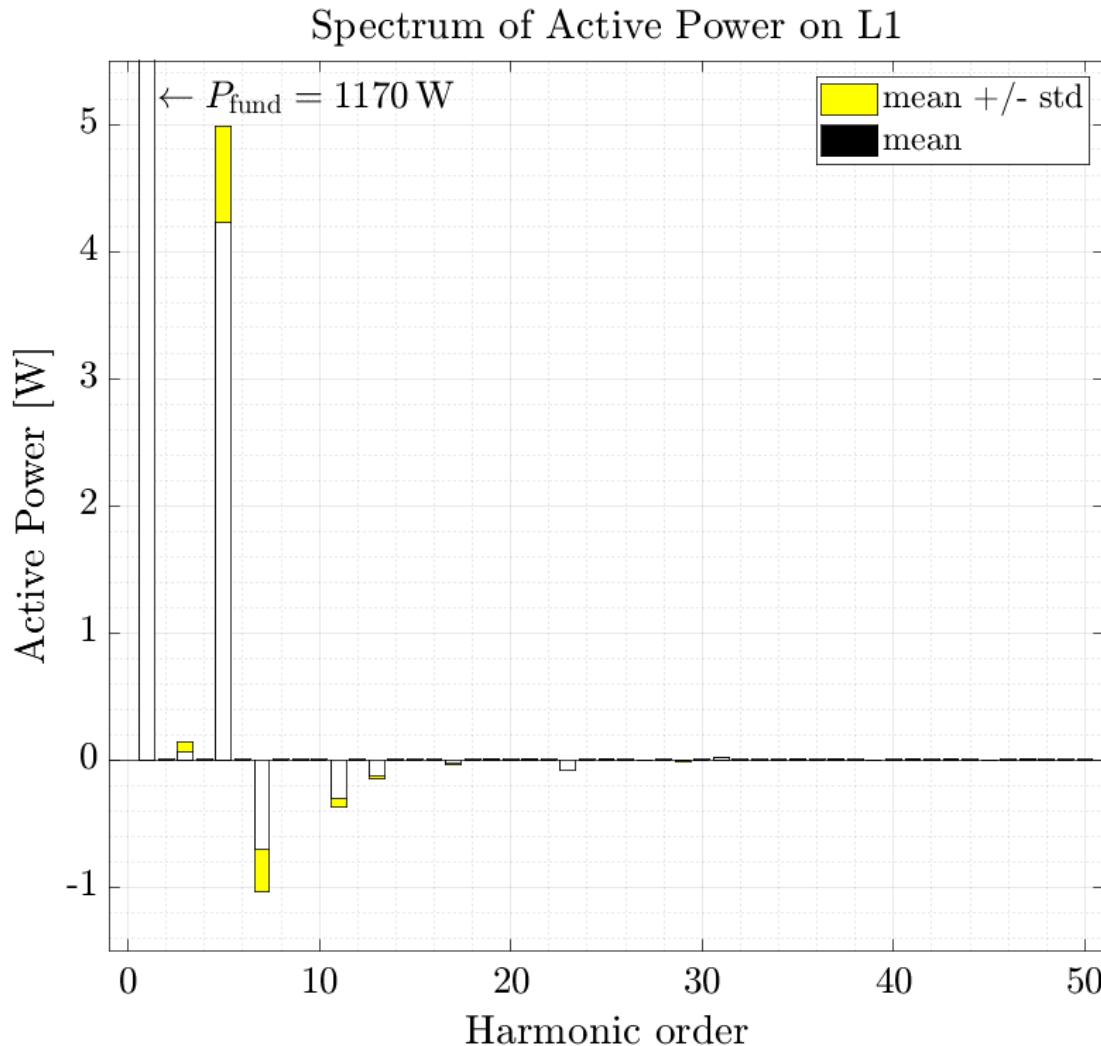
Measurements: Voltage and Current over time



Measurements: Spectrum of Voltage and Current



Measurements: Spectrum of Active and Reactive Power



References

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Thank you
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